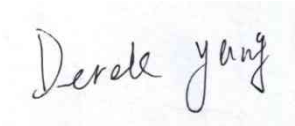
FCC TEST REPORT

Application No.:	HR/2020/B0007
Applicant:	Honor Device Co., Ltd.
Address of Applicant	Suite 3401, Unit A, Building 6, Shum Yip Sky Park, No. 8089, Hongli West Road, Xiangmihu Street, Futian District, Shenzhen, Guangdong 518040, People's Republic of China
Manufacturer:	Honor Device Co., Ltd.
Address of Manufacturer	Suite 3401, Unit A, Building 6, Shum Yip Sky Park, No. 8089, Hongli West Road, Xiangmihu Street, Futian District, Shenzhen, Guangdong 518040, People's Republic of China
EUT Description:	Smart Phone
Model No.:	CHL-LX1
Trade Mark:	HONOR
FCC ID:	2AYGCCHL-LX1
Standards:	47 CFR FCC Part 2, Subpart J 47 CFR Part 15, Subpart C
Date of Receipt:	2020/12/9
Date of Test:	2020/12/9 to 2020/12/31
Date of Issue:	2021/2/22
Test Result :	**PASS ***

* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Authorized Signature:



Derek Yang
Wireless Laboratory Manager

1 Version

Revision Record				
Version	**Chapter**	**Date**	**Modifier**	**Remark**
01		2020-12-31		Original
02		2021-2-22		Comment Revised

Authorized for issue by:				
Tested By		Mike Hu **(Mike Hu) /Project Engineer**		
Checked By		David Chen **(David Chen) /Reviewer**		

2 Test Summary

Test Item	Test Requirement	Test Method	Test Result	Result
AC Power Line Conducted Emission	15.207	ANSI C63.10 (2013)	Clause 4.3	PASS
Conducted Peak Output Power	15.247 (b)(1)	ANSI C63.10 (2013)	Clause 4.4	PASS
20dB Emission Bandwidth & 99% Occupied Bandwidth	15.247 (a)(1)	ANSI C63.10 (2013)	Clause 4.5	PASS
Carrier Frequencies Separation	15.247 (a)(1)	ANSI C63.10 (2013)	Clause 4.6	PASS
Hopping Channel Number	15.247 (a)(1)	ANSI C63.10 (2013)	Clause 4.7	PASS
Dwell Time	15.247 (a)(1)	ANSI C63.10 (2013)	Clause 4.8	PASS
Band-edge for RF Conducted Emissions	15.247(d)	ANSI C63.10 (2013)	Clause 4.9	PASS
RF Conducted Spurious Emissions	15.247(d)	ANSI C63.10 (2013)	Clause 4.10	PASS
Radiated Spurious emissions	15.247(d); 15.205/15.209	ANSI C63.10 (2013)	Clause 4.11	PASS
Restricted bands around fundamental frequency (Radiated Emission)	15.247(d); 15.205/15.209	ANSI C63.10 (2013)	Clause 4.12	PASS

Contents

3 General Information

3.1 Details of Client

Applicant:	Honor Device Co., Ltd.
Address of Applicant	Suite 3401, Unit A, Building 6, Shum Yip Sky Park, No. 8089, Hongli West Road, Xiangmihu Street, Futian District, Shenzhen, Guangdong 518040, People's Republic of China
Manufacturer:	Honor Device Co., Ltd.
Address of Manufacturer	Suite 3401, Unit A, Building 6, Shum Yip Sky Park, No. 8089, Hongli West Road, Xiangmihu Street, Futian District, Shenzhen, Guangdong 518040, People's Republic of China

3.2 Test Location

Company:	SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch
Address:	No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China
Post code:	518057

3.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2017 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

• A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• FCC –Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

• Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

3.4 General Description of EUT

EUT Description:	Smart Phone
Model No.:	CHL-LX1
Trade Mark:	HONOR
Hardware Version:	HL3CHLM
Software Version:	5.0.1.69(C900E12R1P2)
Operation Frequency:	2400MHz~2483.5MHz fc = 2402 MHz + N * 2 MHz, where: -fc = “Operating Frequency” in MHz, -N = “Channel Number” with the range from 0 to 39.
Bluetooth version:	Bluetooth V5.1 LE
Modulation Technique:	Frequency Hopping Spread Spectrum(FHSS)
Modulation Type:	GFSK, π/4DQPSK, 8DPSK
Number of Channel:	79
Hopping Channel Type:	Adaptive Frequency Hopping systems
Sample Type:	☒ Portable Device, ☐ Module
Antenna Type:	☐ External, ☒ Integrated
Antenna Gain:	-2.0dBi
Power Supply	☒ AC/DC Adapter; ☐ Battery ☐ PoE:; ☐ Other:

Operation Frequency of each channel							
Channel	**Frequency**	**Channel**	**Frequency**	**Channel**	**Frequency**	**Channel**	**Frequency**
0	2402MHz	20	2422MHz	40	2442MHz	60	2462MHz
1	2403MHz	21	2423MHz	41	2443MHz	61	2463MHz
2	2404MHz	22	2424MHz	42	2444MHz	62	2464MHz
3	2405MHz	23	2425MHz	43	2445MHz	63	2465MHz
4	2406MHz	24	2426MHz	44	2446MHz	64	2466MHz
5	2407MHz	25	2427MHz	45	2447MHz	65	2467MHz
6	2408MHz	26	2428MHz	46	2448MHz	66	2468MHz
7	2409MHz	27	2429MHz	47	2449MHz	67	2469MHz
8	2410MHz	28	2430MHz	48	2450MHz	68	2470MHz
9	2411MHz	29	2431MHz	49	2451MHz	69	2471MHz
10	2412MHz	30	2432MHz	50	2452MHz	70	2472MHz
11	2413MHz	31	2433MHz	51	2453MHz	71	2473MHz
12	2414MHz	32	2434MHz	52	2454MHz	72	2474MHz
13	2415MHz	33	2435MHz	53	2455MHz	73	2475MHz
14	2416MHz	34	2436MHz	54	2456MHz	74	2476MHz
15	2417MHz	35	2437MHz	55	2457MHz	75	2477MHz

16	2418MHz	36	2438MHz	56	2458MHz	76	2478MHz
17	2419MHz	37	2439MHz	57	2459MHz	77	2479MHz
18	2420MHz	38	2440MHz	58	2460MHz	78	2480MHz
19	2421MHz	39	2441MHz	59	2461MHz		

Remark:
In section 15.31(m), regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

Channel	Frequency
The Lowest channel(CH0)	2402MHz
The Middle channel(CH39)	2441MHz
The Highest channel(CH78)	2480MHz

3.5 Test Environment

Operating Environment:	
Temperature:	25.0 ˚C
Humidity:	50 % RH
Atmospheric Pressure:	101.30 KPa

3.6 Description of Support Units

The EUT has been tested independent unit.

4 Test results and Measurement Data

4.1 Antenna Requirement

Standard requirement:	47 CFR Part 15C Section 15.203 /247(c)
15.203 requirement: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. 15.247(b) (4) requirement: The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.	
The antenna is integrated on the main PCB and no consideration of replacement. The best case gain of the antenna is -2.0dBi.	

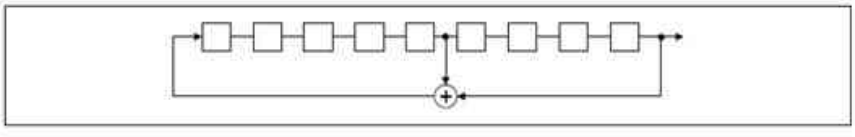
4.2 Other requirements Frequency Hopping Spread Spectrum System Hopping Sequence

4.2.1 Test Requirement:

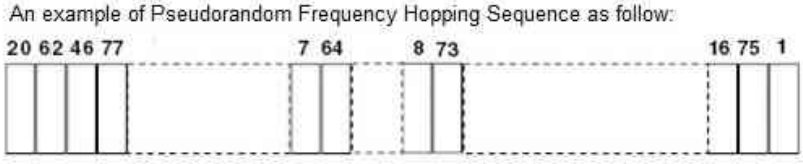
47 CFR Part 15, Subpart C 15.247(a)(1),(g),(h)

4.2.2 Conclusion

Standard Requirement:
The system shall hop to channel frequencies that are selected at the system hopping rate from a Pseudorandom ordered list of hopping frequencies. Each frequency must be used equally on the average by each transmitter. The system receivers shall have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.
Frequency hopping spread spectrum systems are not required to employ all available hopping channels during each transmission. However, the system, consisting of both the transmitter and the receiver, must be designed to comply with all of the regulations in this section should the transmitter be presented with a continuous data (or information) stream. In addition, a system employing short transmission bursts must comply with the definition of a frequency hopping system and must distribute its transmissions over the minimum number of hopping channels specified in this section.
The incorporation of intelligence within a frequency hopping spread spectrum system that permits the system to recognize other users within the spectrum band so that it individually and independently chooses and adapts its hopsets to avoid hopping on occupied channels is permitted. The coordination of frequency hopping systems in any other manner for the express purpose of avoiding the simultaneous occupancy of individual hopping frequencies by multiple transmitters is not permitted.
Compliance for section 15.247(a)(1):
According to Technical Specification, the pseudorandom sequence may be generated in a nine-stage shift register whose 5th and 9th stage outputs are added in a modulo-two addition stage. And the result is fed back to the input of the first stage. The sequence begins with the first ONE of 9 consecutive ONEs; i.e. the shift register is initialized with nine ones.
> Number of shift register stages: 9
> Length of pseudo-random sequence: 29 -1 = 511 bits
> Longest sequence of zeros: 8 (non-inverted signal)
Linear Feedback Shift Register for Generation of the PRBS sequence
An example of Pseudorandom Frequency Hopping Sequence as follow:



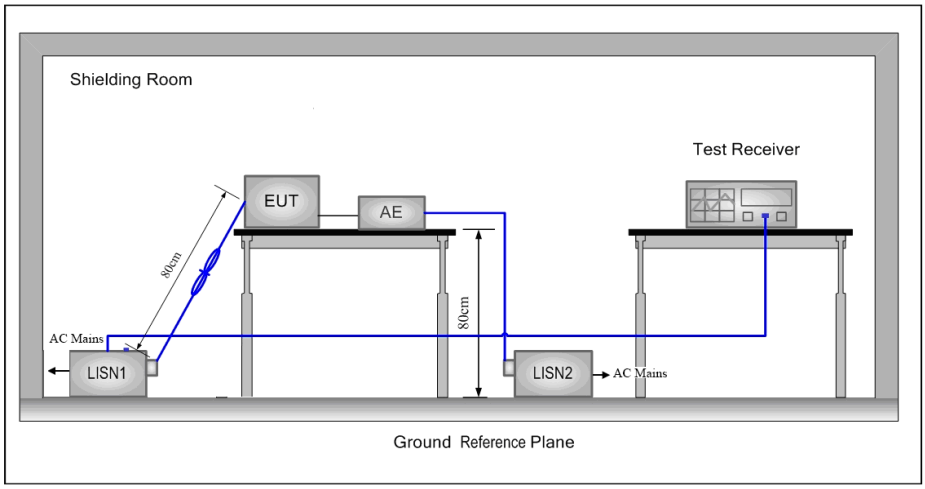
Linear Feedback Shift Register for Generation of the PRBS sequence



Each frequency used equally on the average by each transmitter.
According to Technical Specification, the receivers are designed to have input and IF bandwidths that match the hopping channel bandwidths of any transmitters and shift frequencies in synchronization with the transmitted signals.
Compliance for section 15.247(g):
According to Technical Specification, the system transmits the packet with the pseudorandom hopping frequency with a continuous data and the short burst transmission from the RF system is also transmitted under the frequency hopping system with the pseudorandom hopping frequency system.
Compliance for section 15.247(h):
According to Technical specification, the system incorporates with an adaptive system to detect other user within the spectrum band so that it individually and independently to avoid hopping on the occupied channels. The system is designed not have the ability to coordinated with other FHSS System in an effort to avoid the simultaneous occupancy of individual hopping frequencies by multiple transmitter.

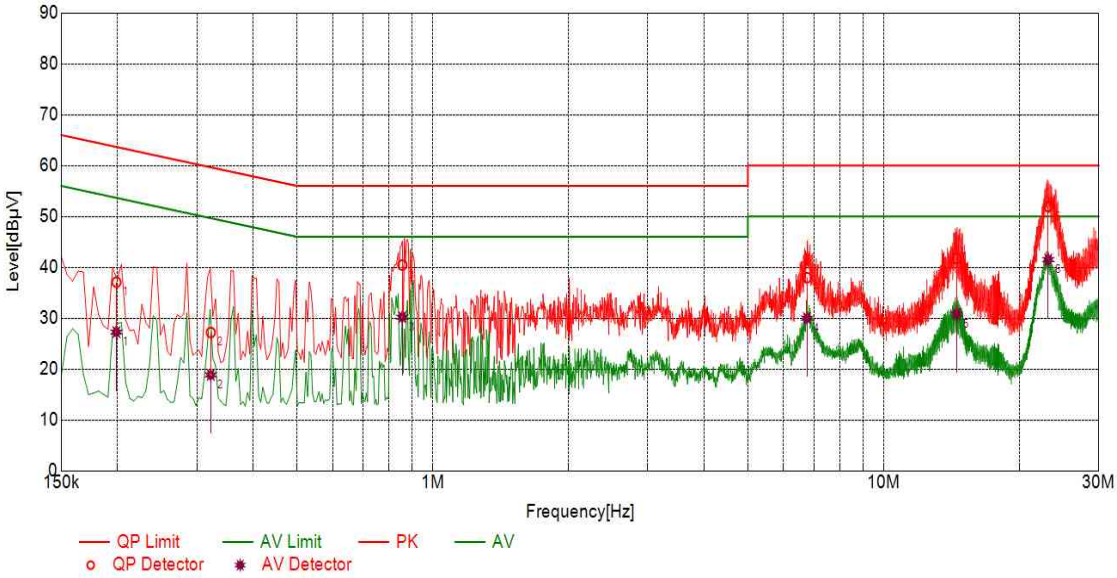
4.3 AC Power Line Conducted Emissions

Test Requirement:	47 CFR Part 15C Section 15.207		
Test Method:	ANSI C63.10: 2013		
Test Frequency Range:	150kHz to 30MHz		
Limit:	Frequency range (MHz)	Limit (dBuV)	
		Quasi-peak	Average
	0.15-0.5	66 to 56*	56 to 46*
	0.5-5	56	46
	5-30	60	50
	* Decreases with the logarithm of the frequency.		
Test Procedure:	1) The mains terminal disturbance voltage test was conducted in a shielded room. 2) The EUT was connected to AC power source through a LISN 1 (Line Impedance Stabilization Network) which provides a 50Ω/50μH + 5Ω linear impedance. The power cables of all other units of the EUT were connected to a second LISN 2, which was bonded to the ground reference plane in the same way as the LISN 1 for the unit being measured. A multiple socket outlet strip was used to connect multiple power cables to a single LISN provided the rating of the LISN was not exceeded. 3) The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane. 4) The test was performed with a vertical ground reference plane. The rear of the EUT shall be 0.4 m from the vertical ground reference plane. The vertical ground reference plane was bonded to the horizontal ground reference plane. The LISN 1 was placed 0.8 m from the boundary of the unit under test and bonded to a ground reference plane for LISNs mounted on top of the ground reference plane. This distance was between the closest points of the LISN 1 and the EUT. All other units of the EUT and associated equipment was at least 0.8 m from the LISN 2. 5) In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.10: 2013 on conducted measurement.		

Test Setup:	
Test Mode:	Non-hopping transmitting mode with all kind of modulation and all kind of data type at the lowest, middle, high channel. Charge + Transmitting mode.
Final Test Mode:	Through Pre-scan, find the DH5 of data type and GFSK modulation at the lowest channel is the worst case. Charge + Transmitting mode Only the worst case is recorded in the report.
Instruments Used:	Refer to section 5.10 for details.
Test Results:	Pass

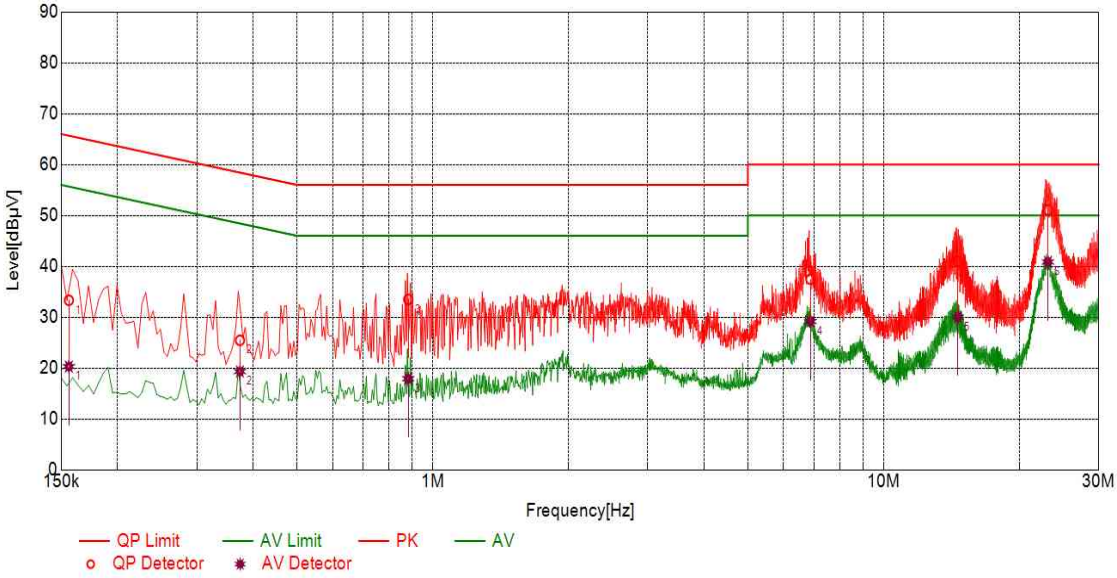
Measurement Data
An initial pre-scan was performed on the live and neutral lines with peak detector.
Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission were detected.

Live Line:



Final Data List									
NO.	Freq. [MHz]	Factor [dB]	QP Value	QP Limit	QP Margin	AV Value	AV Limit	AV Margin	Type
1	0.1989	10.10	37.09	63.66	26.57	27.27	53.66	26.39	L
2	0.3220	10.10	27.20	59.65	32.45	18.86	49.65	30.79	L
3	0.8560	10.10	40.44	56.00	15.56	30.20	46.00	15.80	L
4	6.7626	10.10	37.97	60.00	22.03	30.01	50.00	19.99	L
5	14.5266	10.11	41.76	60.00	18.24	30.82	50.00	19.18	L
6	23.1914	10.11	51.93	60.00	8.07	41.52	50.00	8.48	L

Neutral Line:



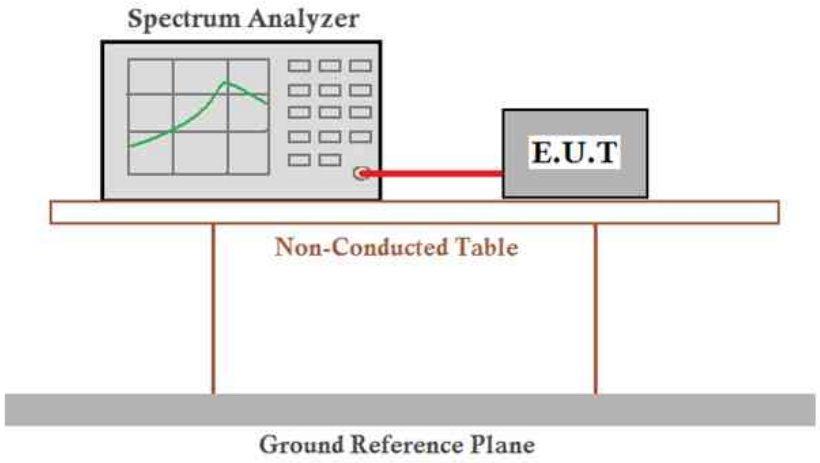
Final Data List									
NO.	Freq. [MHz]	Factor [dB]	QP Value	QP Limit	QP Margin	AV Value	AV Limit	AV Margin	Type
1	0.1560	10.10	33.33	65.68	32.35	20.30	55.68	35.38	N
2	0.3737	10.10	25.46	58.42	32.96	19.32	48.42	29.10	N
3	0.8823	10.10	33.50	56.00	22.50	17.91	46.00	28.09	N
4	6.8820	10.10	37.47	60.00	22.53	29.16	50.00	20.84	N
5	14.6140	10.11	40.97	60.00	19.03	30.05	50.00	19.95	N
6	23.1531	10.11	51.11	60.00	8.89	40.86	50.00	9.14	N

Remarks:

1. The following Quasi-Peak and Average measurements were performed on the EUT:

2. Final Test Level =Receiver Reading + LISN Factor + Cable Loss.

4.4 Conducted Output Power

Test Requirement:	47 CFR Part 15C Section 15.247 (b)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.5
Test Setup:	
Test Instruments:	Refer to section 5.10 for details
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type.
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.
Limit:	(20.97dBm) 125mW
Test Results:	Pass

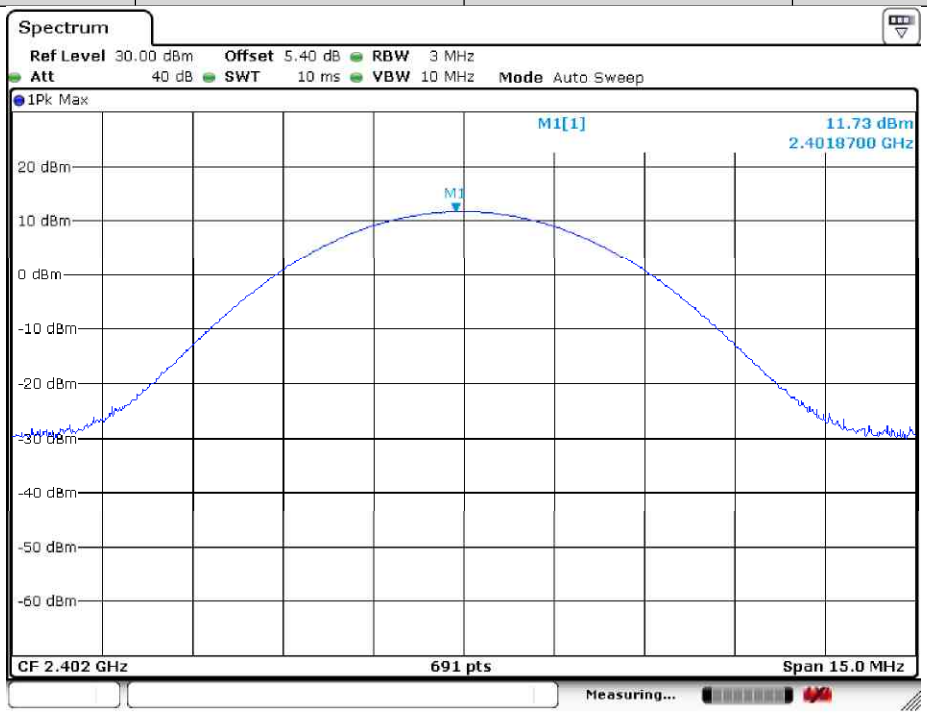
4.4.1 Test Results

Measurement Data of Peak Power:

GFSK mode			
Test Channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	11.73	20.97	Pass
Middle	12.65	20.97	Pass
Highest	12.45	20.97	Pass
π/4DQPSK mode			
Test Channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	11.46	20.97	Pass
Middle	12.13	20.97	Pass
Highest	11.83	20.97	Pass
8DPSK mode			
Test Channel	Peak Output Power (dBm)	Limit (dBm)	Result
Lowest	11.42	20.97	Pass
Middle	12.13	20.97	Pass
Highest	11.87	20.97	Pass

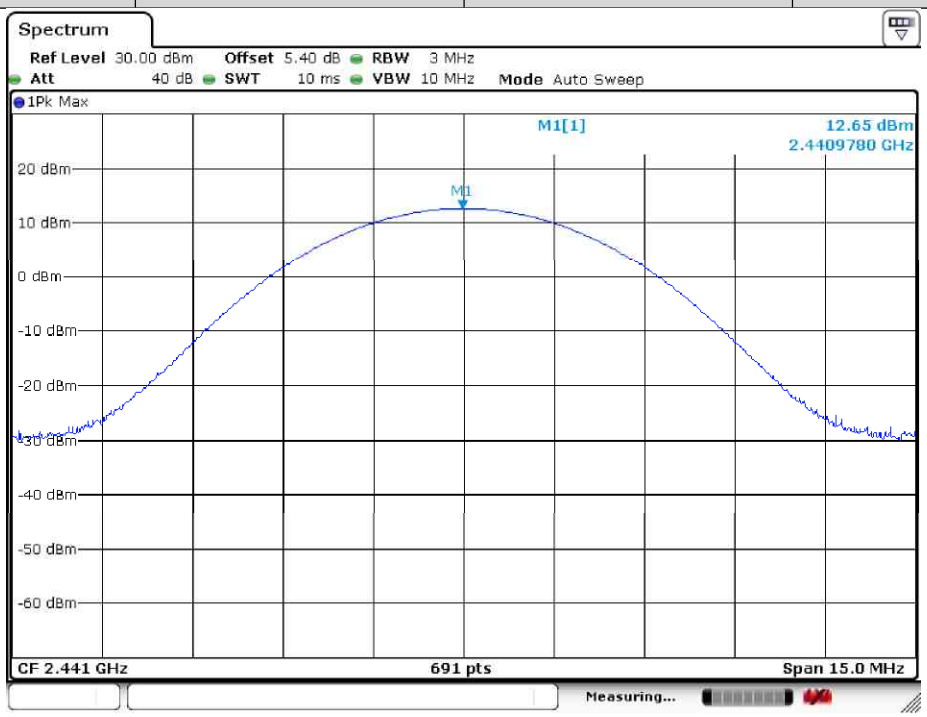
4.4.2 Test Plots

Test mode:	GFSK	Test channel:	Lowest

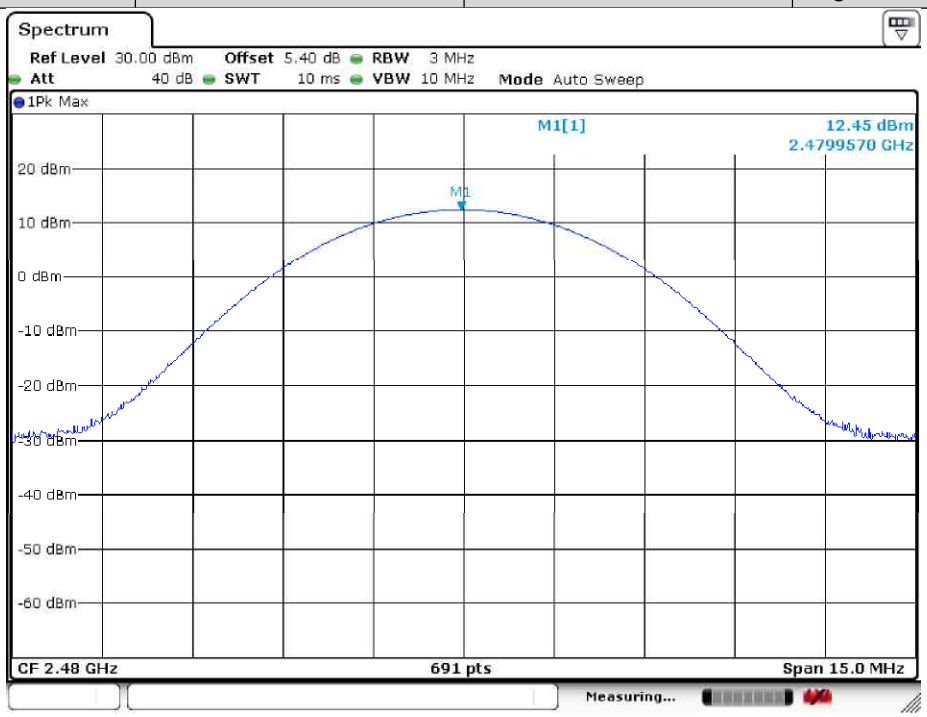


Date: 27.DEC.2020 15:52:50

Test mode:	GFSK	Test channel:	Middle

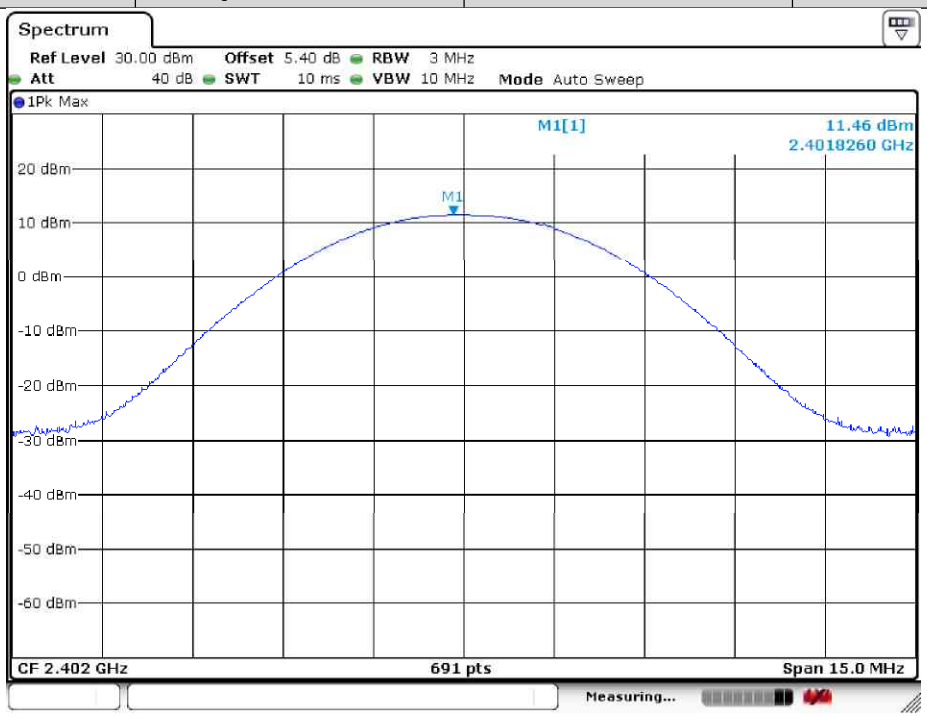


Test mode:	GFSK	Test channel:	Highest



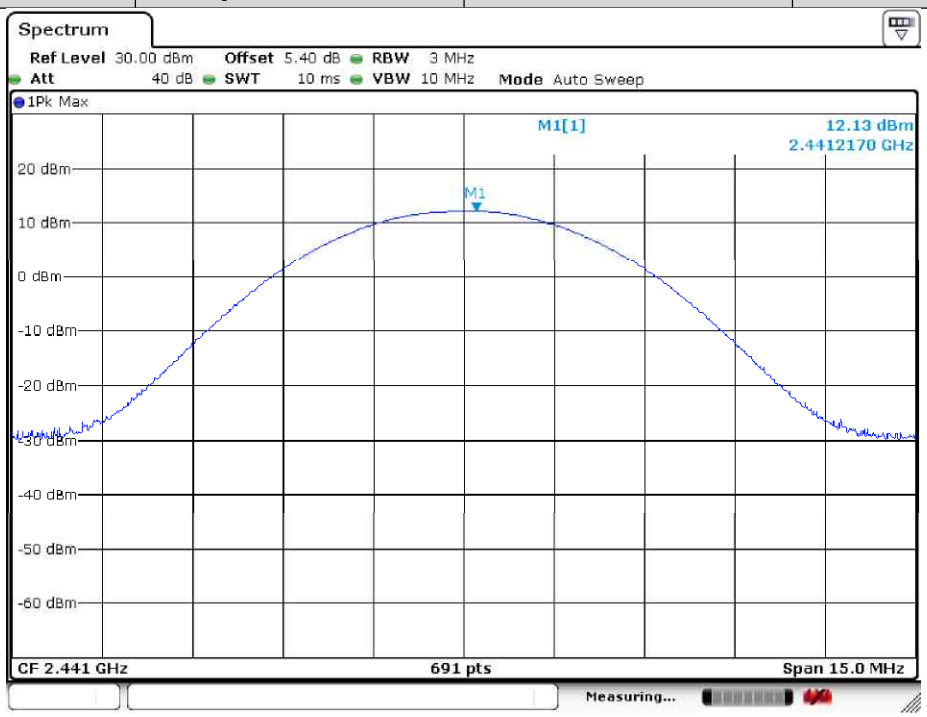
Date: 27.DEC.2020 15:52:34

Test mode:	π/4DQPSK	Test channel:	Lowest



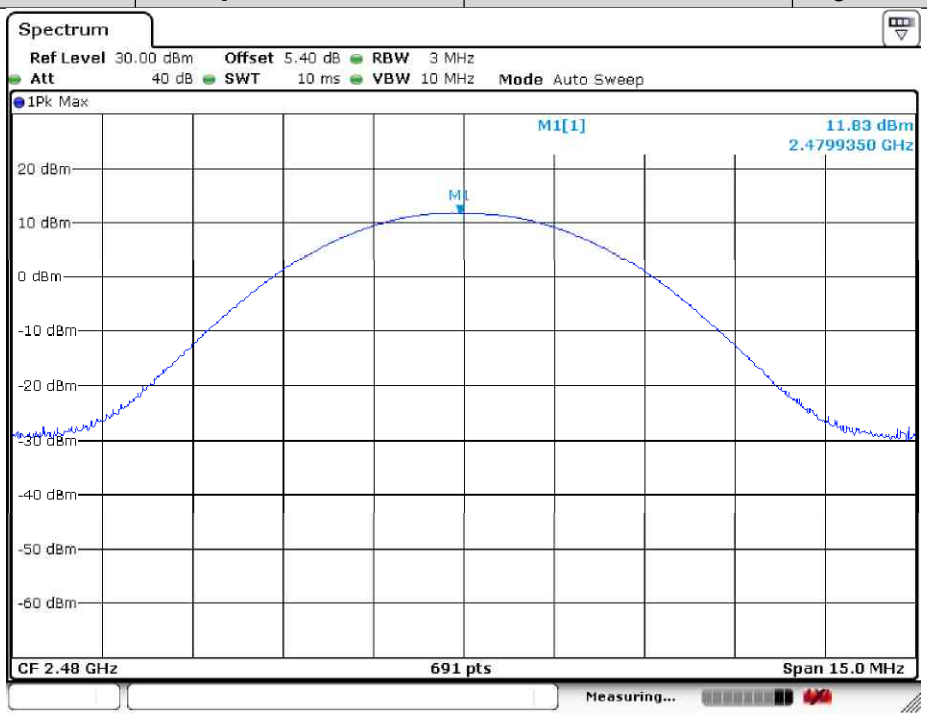
Date: 27.DEC.2020 15:52:02

Test mode:	π/4DQPSK	Test channel:	Middle



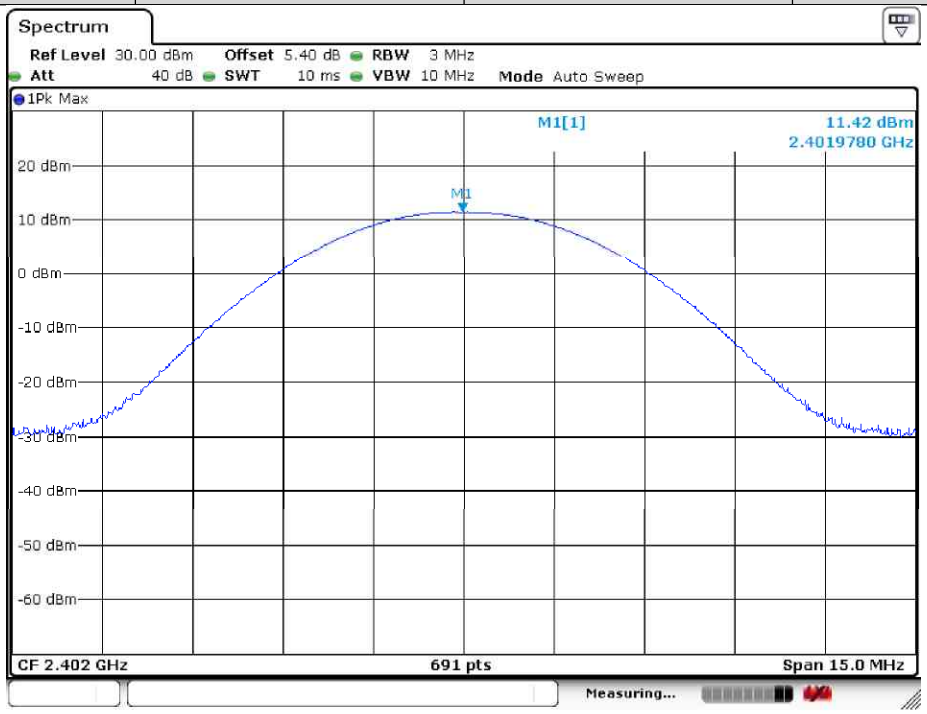
Date: 27.DEC.2020 15:52:11

Test mode:	π/4DQPSK	Test channel:	Highest

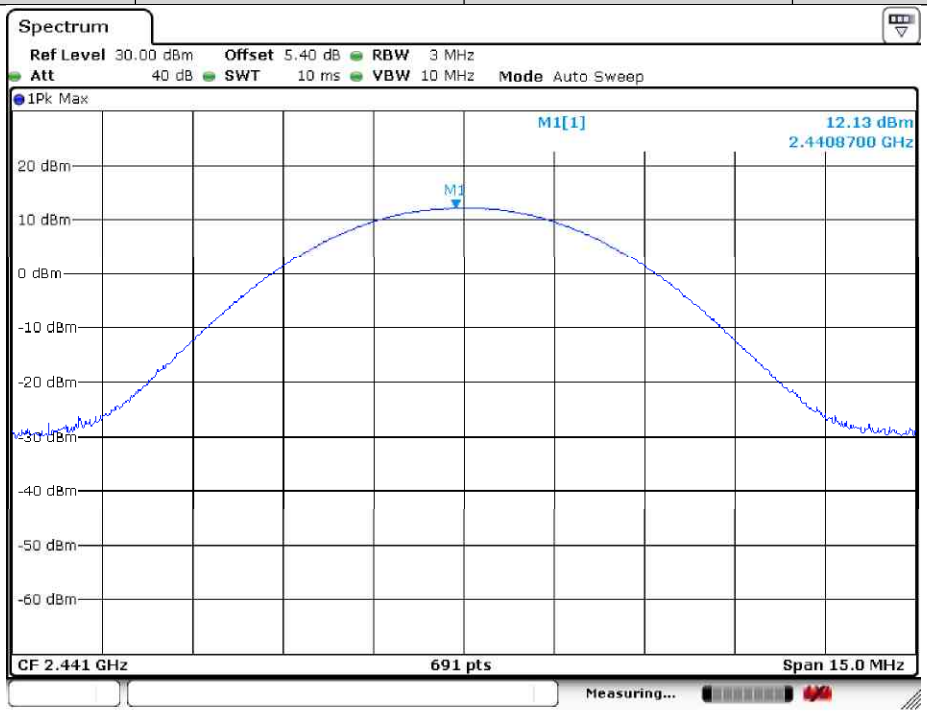


Date: 27.DEC.2020 15:51:26

Test mode:	8DPSK	Test channel:	Lowest

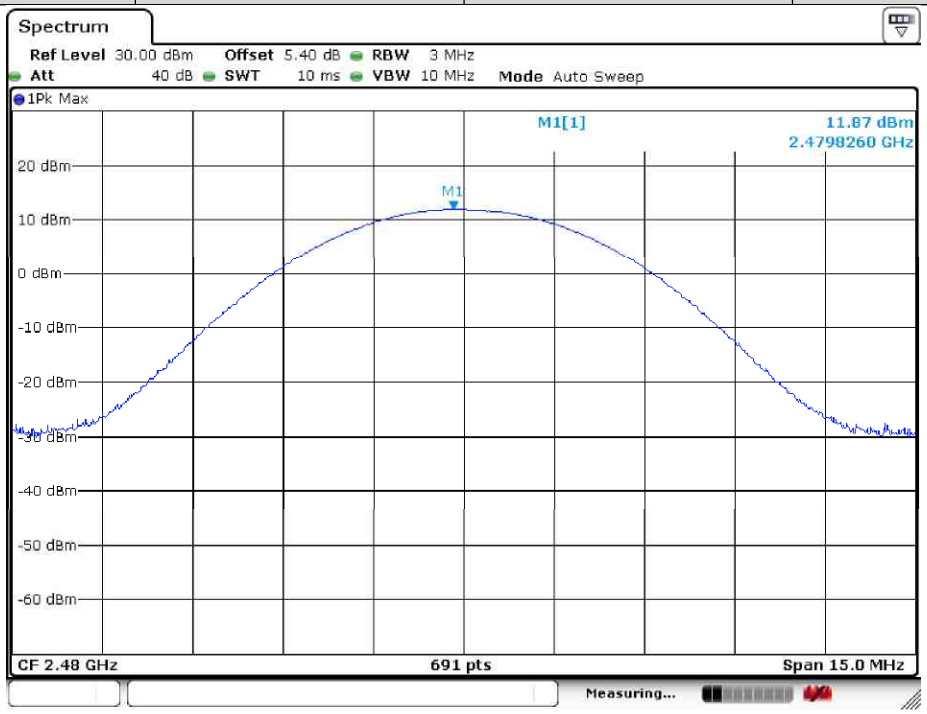


Test mode:	8DPSK	Test channel:	Middle

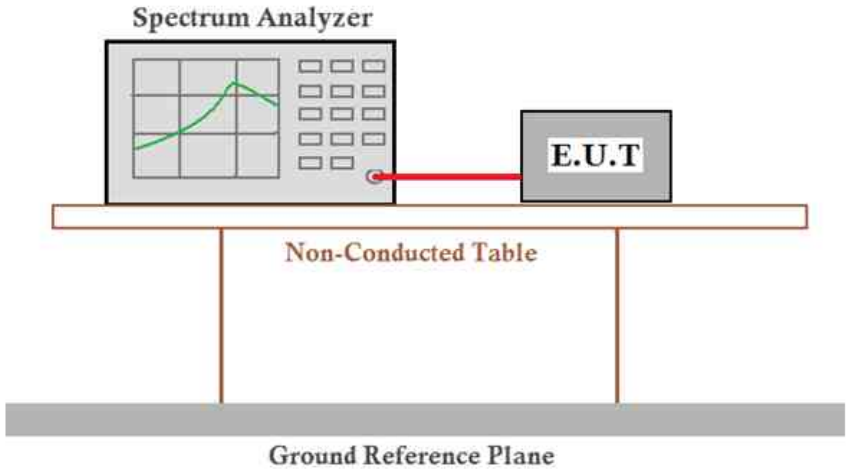


Date: 27.DEC.2020 15:51:43

Test mode:	8DPSK	Test channel:	Highest



4.5 20dB Emission Bandwidth & 99% Occupied Bandwidth

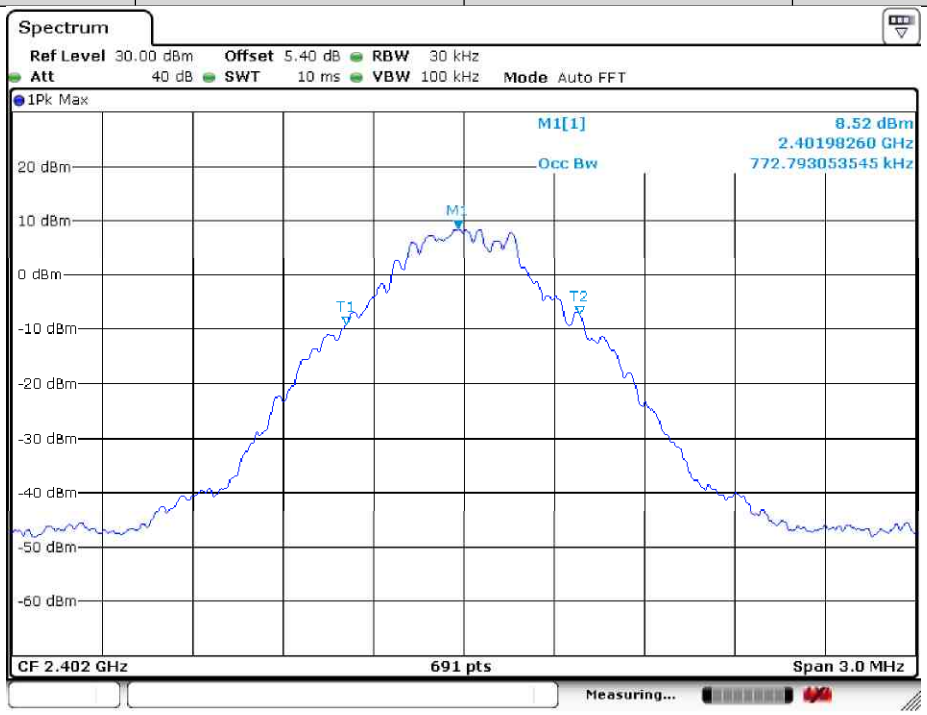
Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.7
Test Setup:	
Instruments Used:	Refer to section 5.10 for details
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type.
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.
Limit:	NA
Test Results:	Pass

4.5.1 Test Results

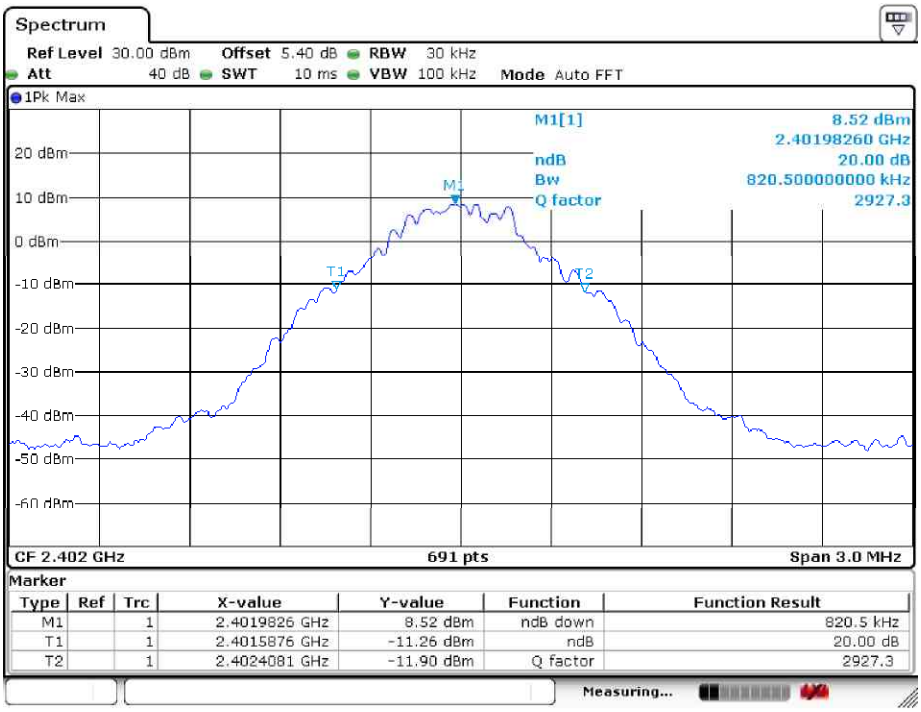
Mode	Test Channel	99% Occupied Bandwidth (KHz)	20dB Emission Bandwidth (KHz)	Result
GFSK	Lowest	772.8	820.5	Pass
	Middle	764.1	820.5	Pass
	Highest	764.1	820.5	Pass
π/4DQPSK	Lowest	1154.8	1267.7	Pass
	Middle	1146.2	1267.7	Pass
	Highest	1150.5	1254.7	Pass
8DPSK	Lowest	1159.2	1276.4	Pass
	Middle	1150.5	1267.7	Pass
	Highest	1150.5	1263.4	Pass

4.5.2 Test Plots

Test mode:	GFSK	Test channel:	Lowest



Date: 27.DEC.2020 15:53:00

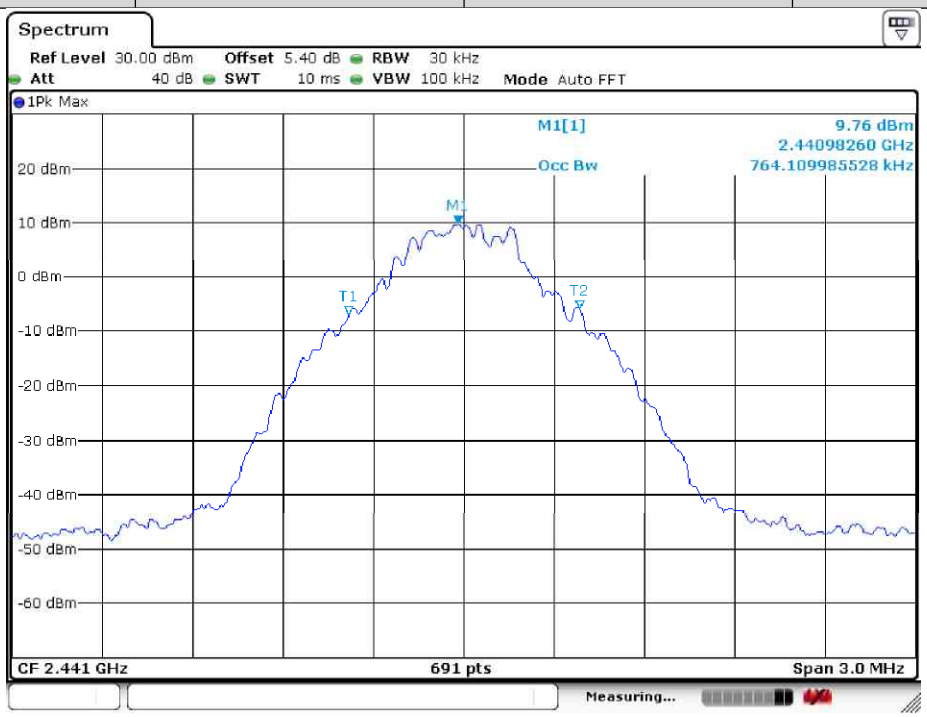


Marker

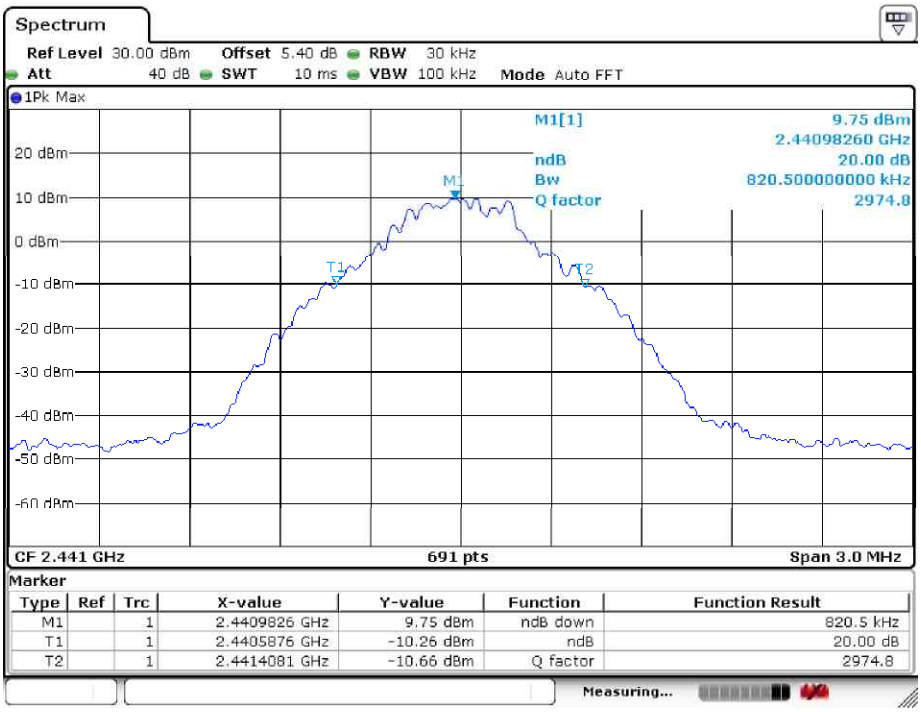
Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4019826 GHz	8.52 dBm	ndB down	820.5 kHz
T1		1	2.4015876 GHz	-11.26 dBm	ndB	20.00 dB
T2		1	2.4024081 GHz	-11.90 dBm	Q factor	2927.3

Date: 27.DEC.2020 15:53:12

Test mode:	GFSK	Test channel:	Middle



Date: 27.DEC.2020 15:53:31

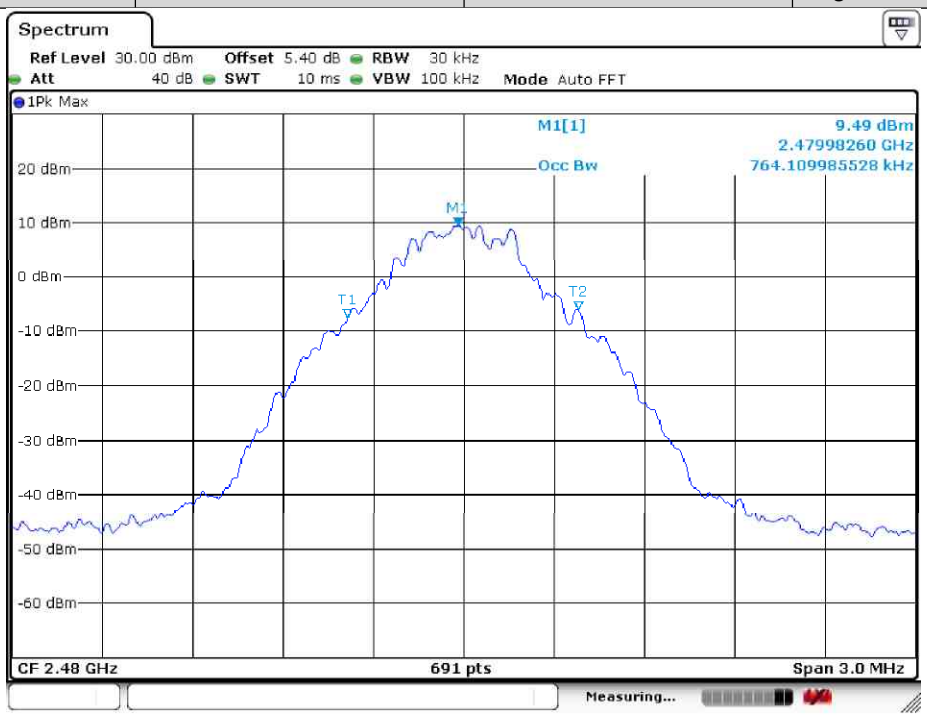


Marker

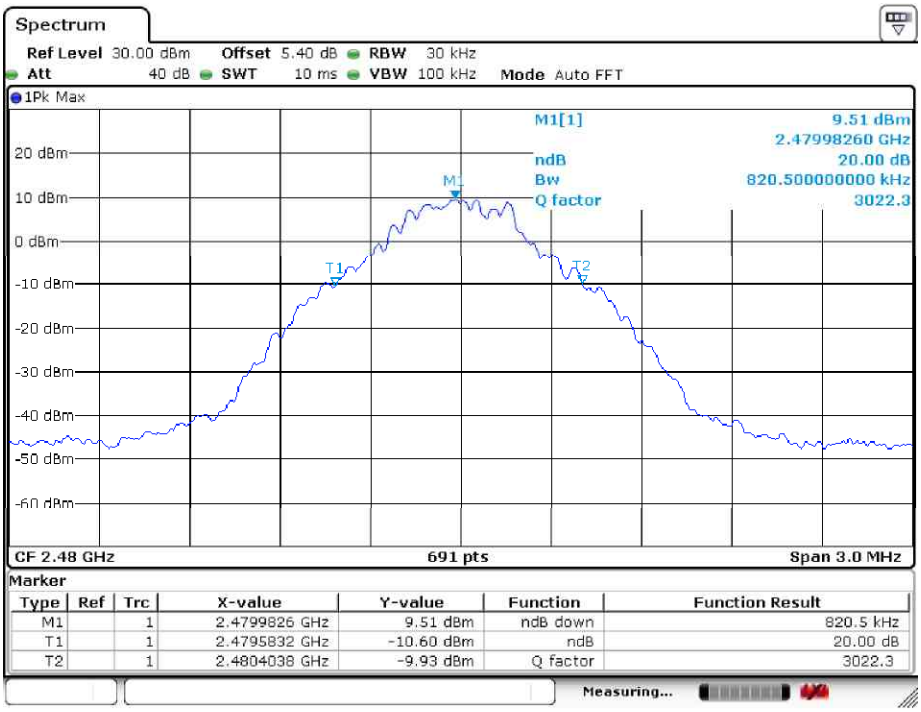
Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4409826 GHz	9.75 dBm	ndB down	820.5 kHz
T1		1	2.4405876 GHz	-10.26 dBm	ndB	20.00 dB
T2		1	2.4414081 GHz	-10.66 dBm	Q factor	2974.8

Date: 27.DEC.2020 15:53:24

Test mode:	GFSK	Test channel:	Highest



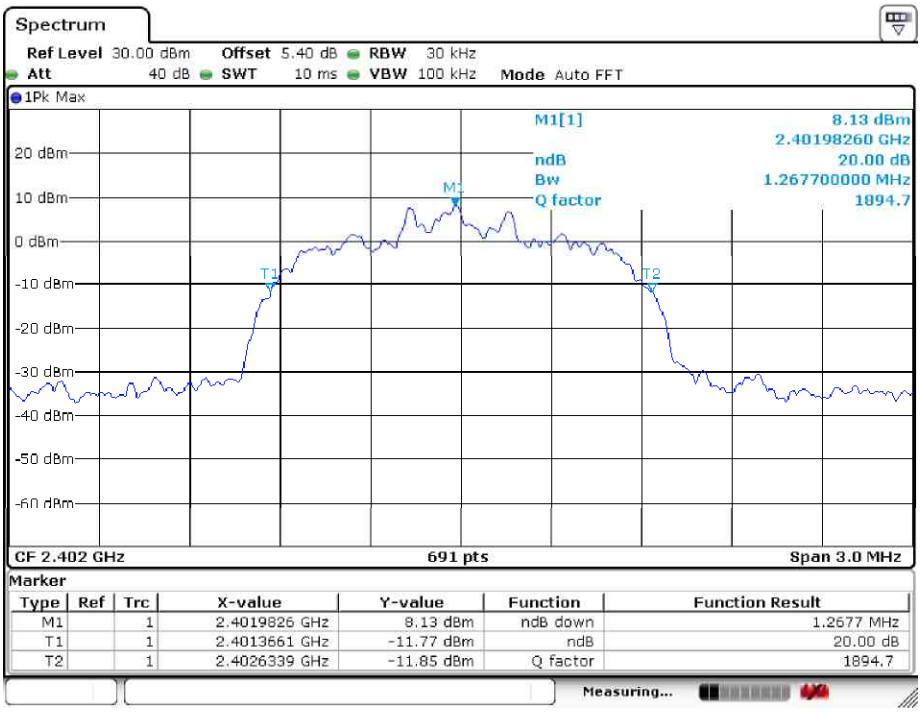
Date: 27.DEC.2020 15:53:42



Date: 27.DEC.2020 15:53:51

Test mode:	π/4DQPSK	Test channel:	Lowest

Date: 27.DEC.2020 15:55:09

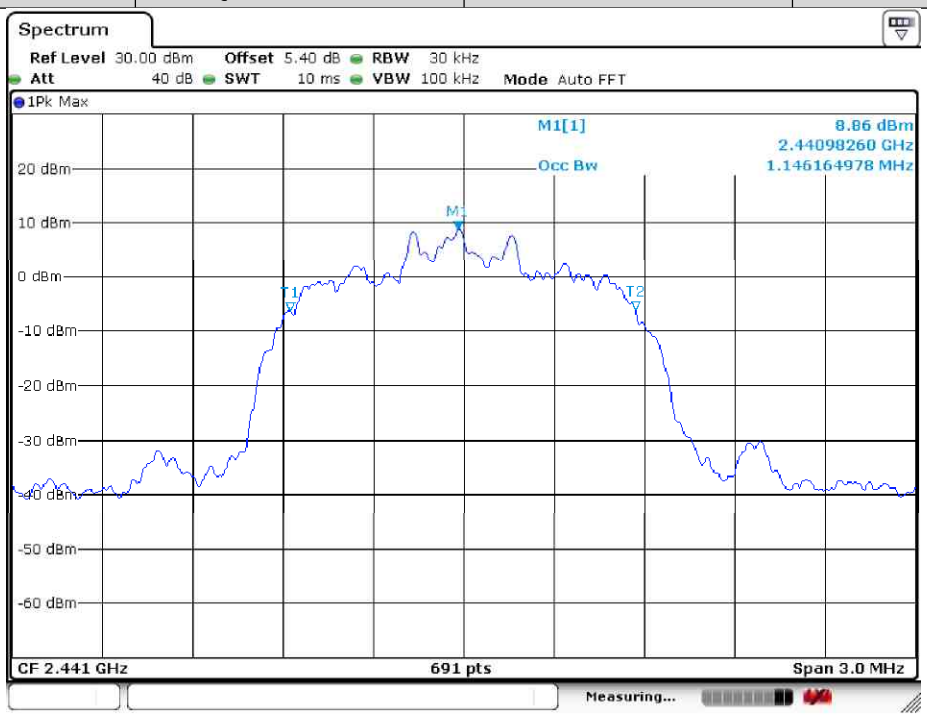


Marker

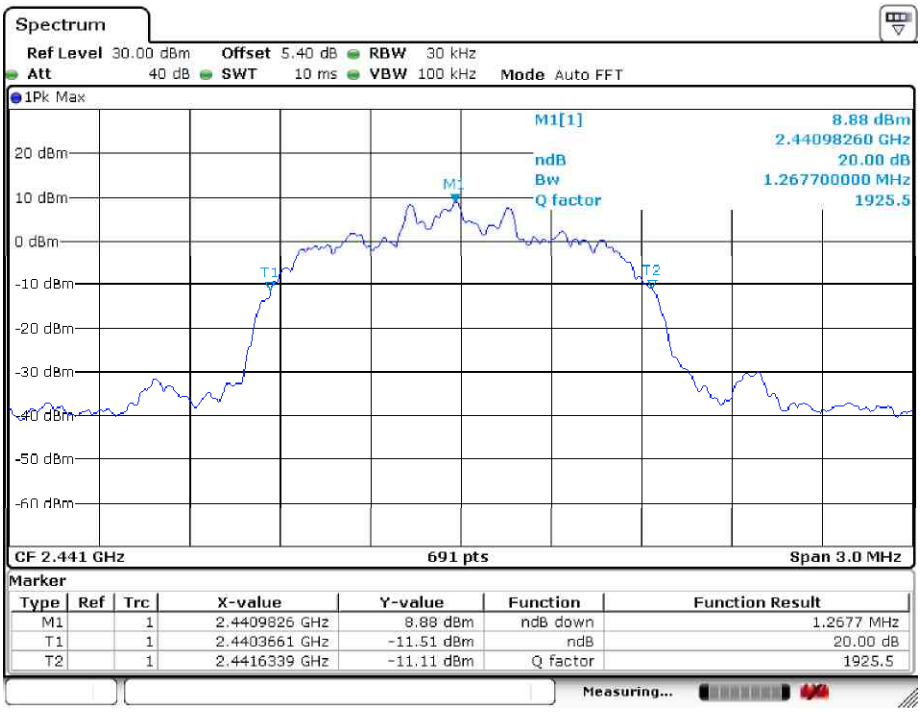
Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4019826 GHz	8.13 dBm	ndB down	1.2677 MHz
T1		1	2.4013661 GHz	-11.77 dBm	ndB	20.00 dB
T2		1	2.4026339 GHz	-11.85 dBm	Q factor	1894.7

Date: 27.DEC.2020 15:54:59

Test mode:	π/4DQPSK	Test channel:	Middle



Date: 27.DEC.2020 15:54:36

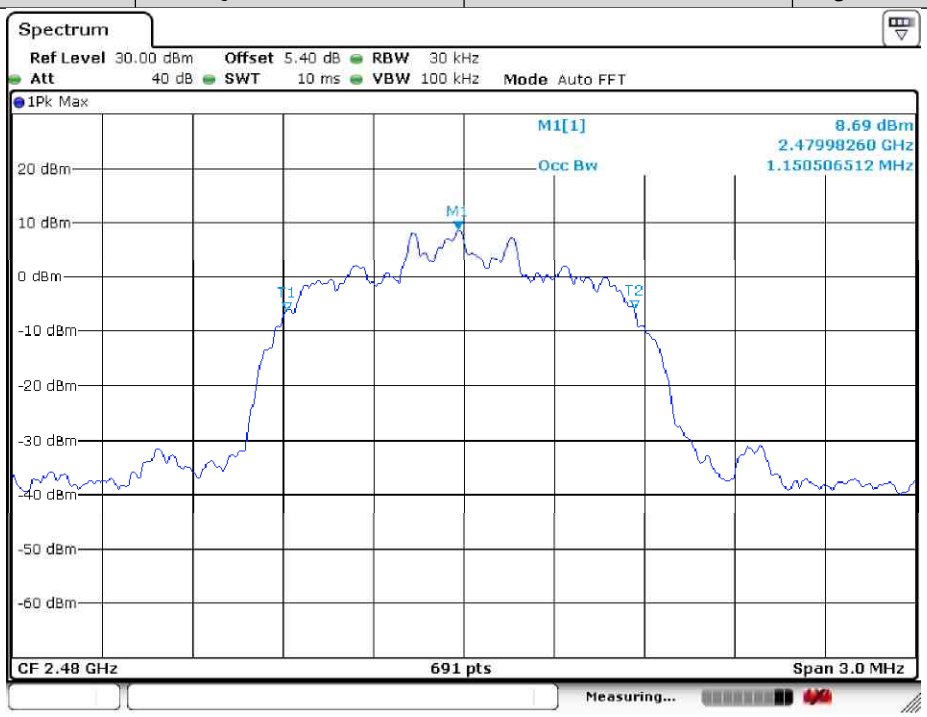


Marker

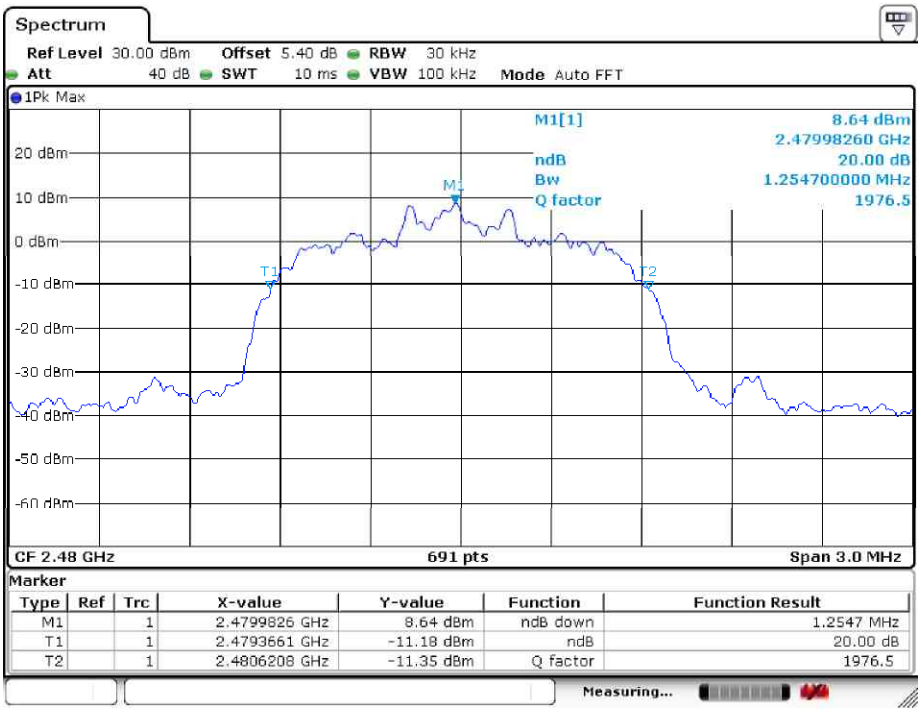
Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4409826 GHz	8.88 dBm	ndB down	1.2677 MHz
T1		1	2.4403661 GHz	-11.51 dBm	ndB	20.00 dB
T2		1	2.4416339 GHz	-11.11 dBm	Q factor	1925.5

Date: 27.DEC.2020 15:54:46

Test mode:	π/4DQPSK	Test channel:	Highest



Date: 27.DEC.2020 15:54:16

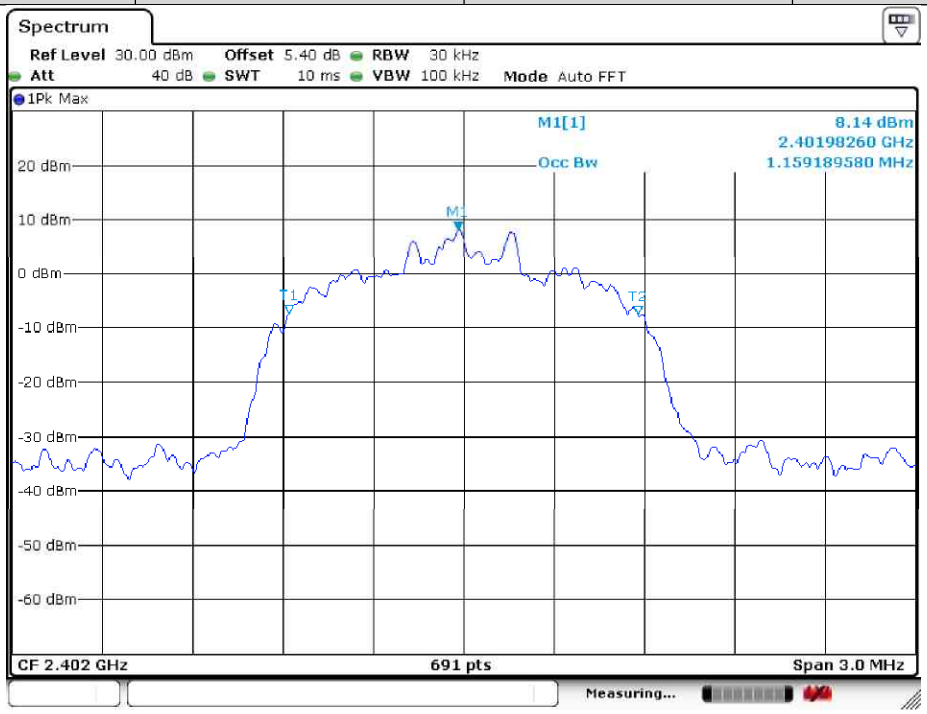


Marker

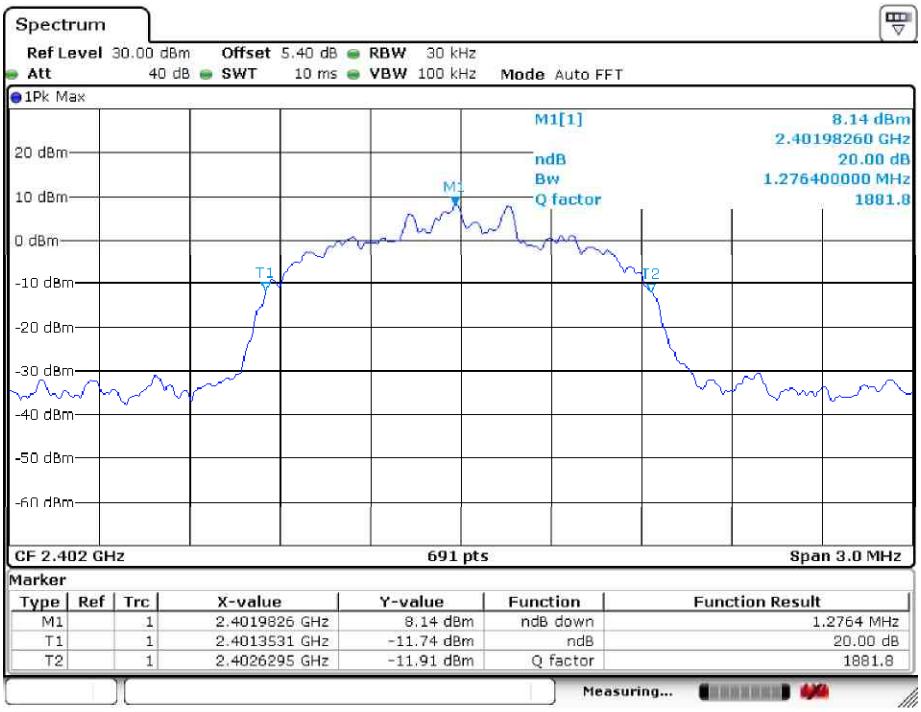
Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4799826 GHz	8.64 dBm	ndB down	1.2547 MHz
T1		1	2.4793661 GHz	-11.18 dBm	ndB	20.00 dB
T2		1	2.4806208 GHz	-11.35 dBm	Q factor	1976.5

Date: 27.DEC.2020 15:54:04

Test mode:	8DPSK	Test channel:	Lowest



Date: 27.DEC.2020 15:55:22

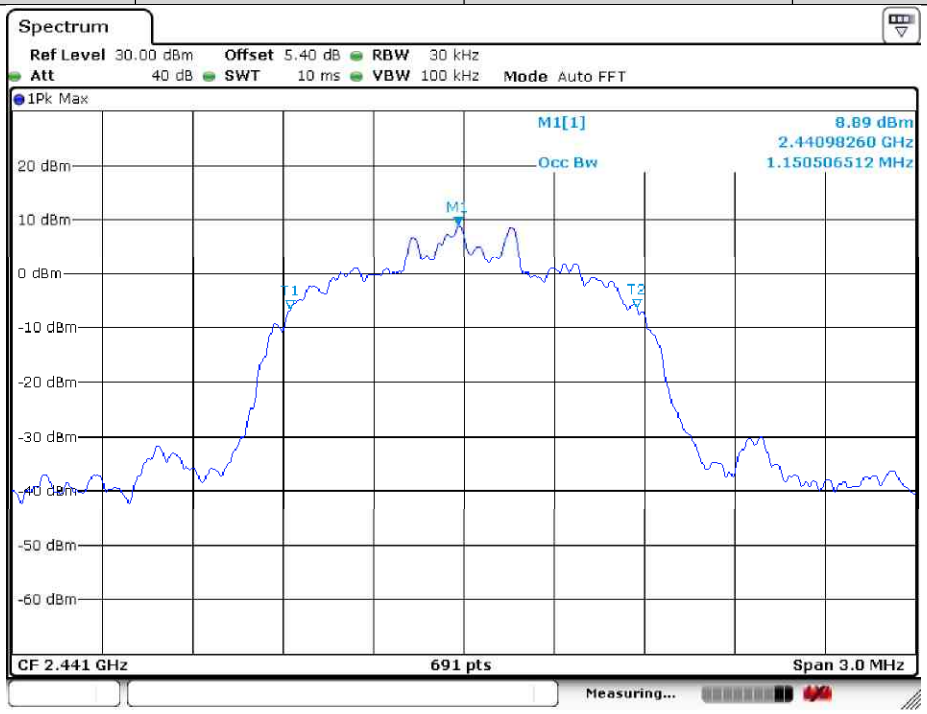


Marker

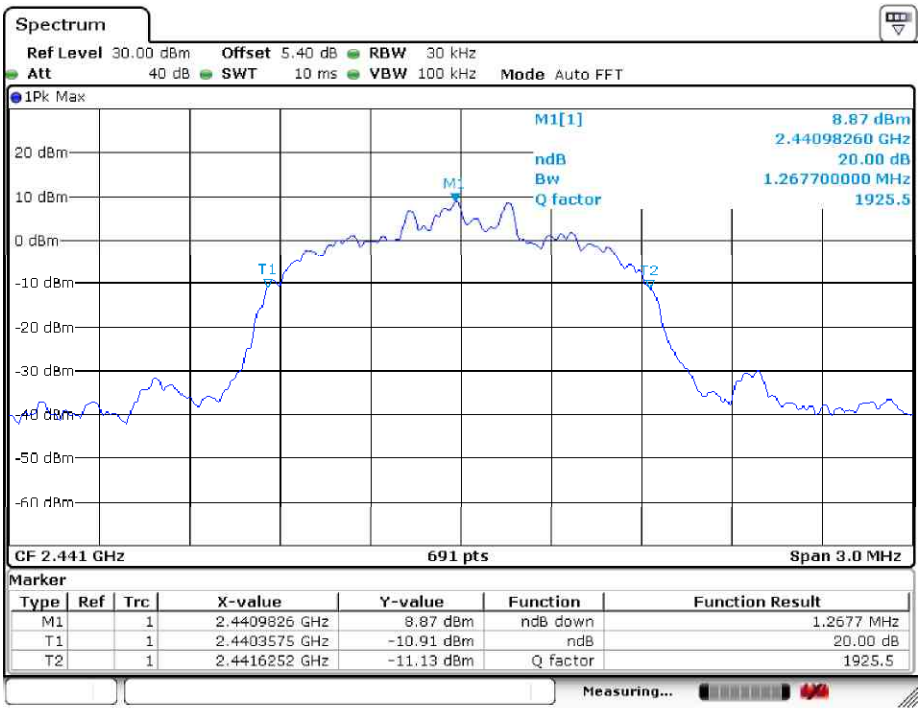
Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4019826 GHz	8.14 dBm	ndB down	1.2764 MHz
T1		1	2.4013531 GHz	-11.74 dBm	ndB	20.00 dB
T2		1	2.4026295 GHz	-11.91 dBm	Q factor	1881.8

Date: 27.DEC.2020 15:55:36

Test mode:	8DPSK	Test channel:	Middle



Date: 27.DEC.2020 15:55:58

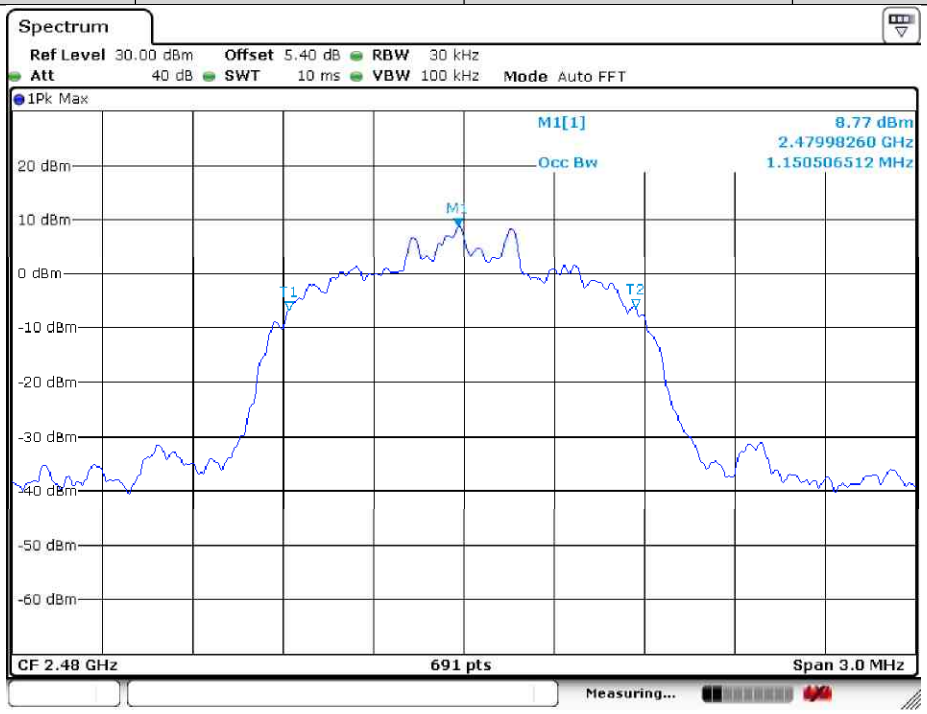


Marker

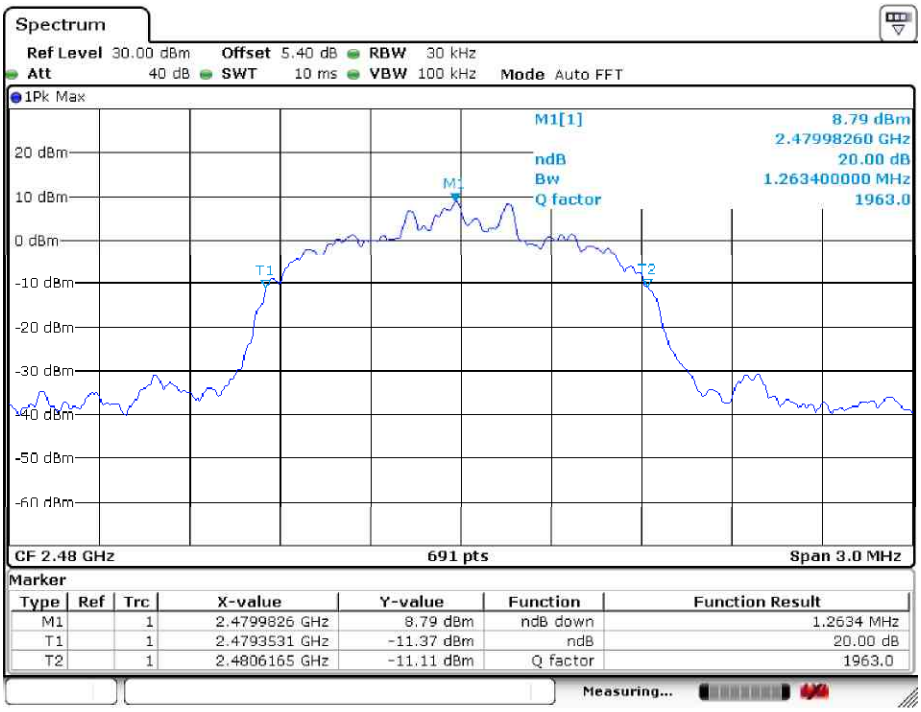
Type	Ref	Trc	X-value	Y-value	Function	Function Result
M1		1	2.4409826 GHz	8.87 dBm	ndB down	1.2677 MHz
T1		1	2.4403575 GHz	-10.91 dBm	ndB	20.00 dB
T2		1	2.4416252 GHz	-11.13 dBm	Q factor	1925.5

Date: 27.DEC.2020 15:55:49

Test mode:	8DPSK	Test channel:	Highest

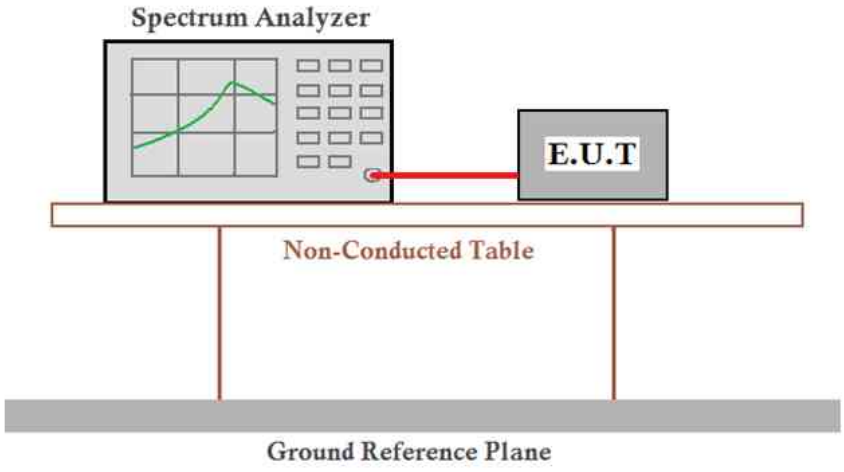


Date: 27.DEC.2020 15:56:10



Date: 27.DEC.2020 15:56:26

4.6 Carrier Frequencies Separation

Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.2
Test Setup:	
Test Instruments:	Refer to section 5.10 for details
Exploratory Test Mode:	Hopping transmitting with all kind of modulation and all kind of data type.
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.
Limit:	2/3 of the 20dB bandwidth
	Remark: the transmission power is less than 0.125W.
Test Results:	Pass

4.6.1 Test Results

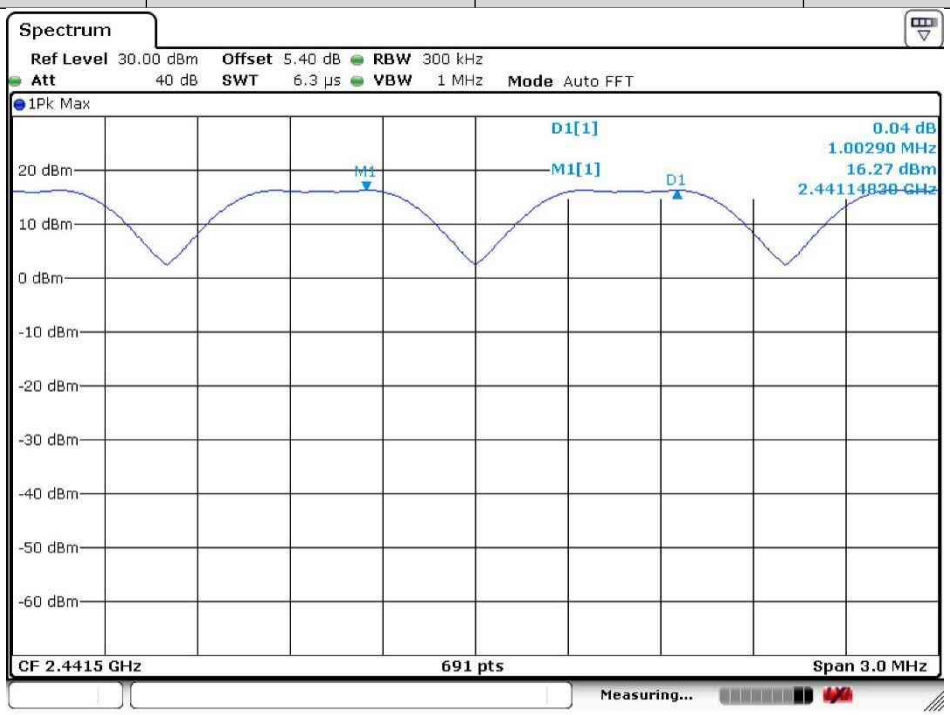
GFSK mode			
Test channel	**Carrier Frequencies Separation (kHz)**	**Limit (kHz)**	**Result**
Middle	1003	547.0	PASS
π/4DQPSK mode			
Test channel	**Carrier Frequencies Separation (kHz)**	**Limit (kHz)**	**Result**
Middle	1016	845.1	PASS
8DPSK mode			
Test channel	**Carrier Frequencies Separation (kHz)**	**Limit (kHz)**	**Result**
Middle	1012	850.9	PASS

Remark: According to section 4.5,

Mode	20dB bandwidth (kHz) (worse case)	Limit (kHz) (Carrier Frequencies Separation)
GFSK	820.5	547.0
π/4DQPSK	1267.7	845.1
8DPSK	1276.4	850.9

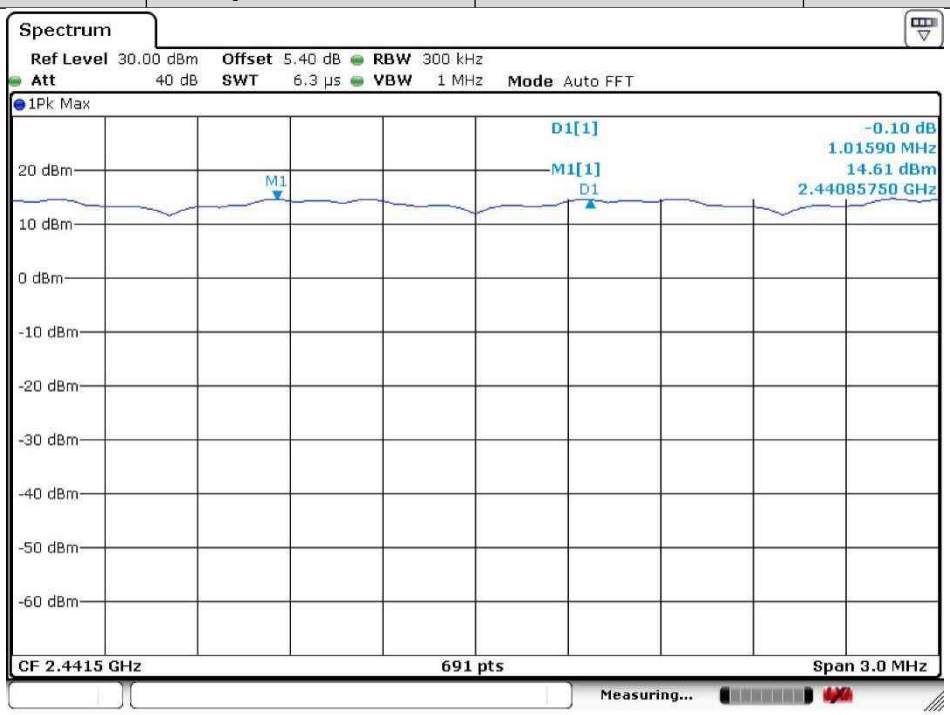
4.6.2 Test Plots

Test mode:	GFSK	Test channel:	Middle



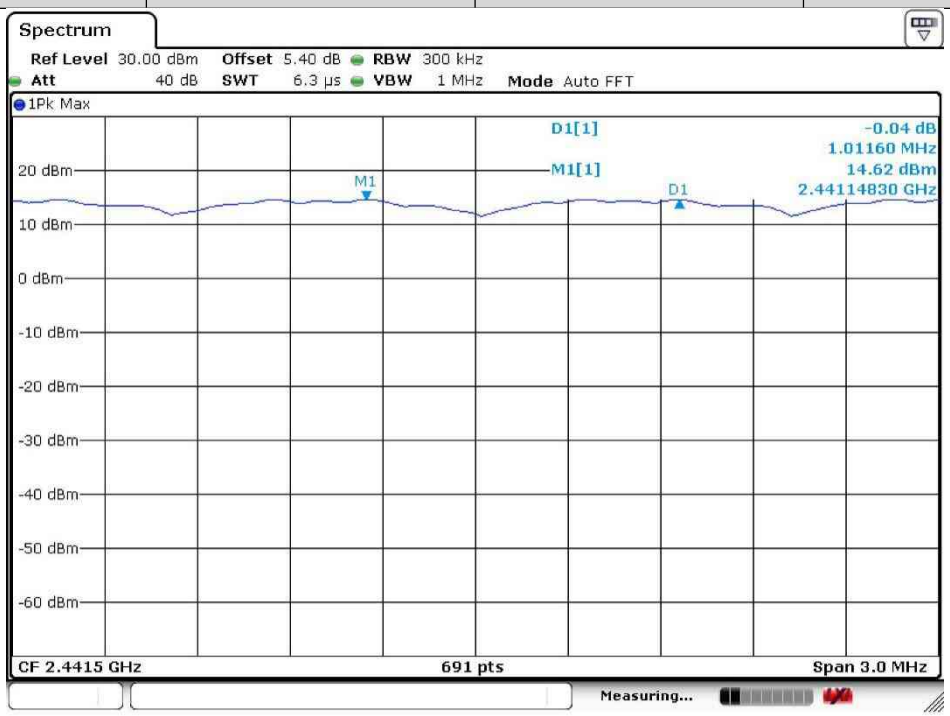
Date: 4.FEB.2021 17:20:42

Test mode:	π/4DQPSK	Test channel:	Middle



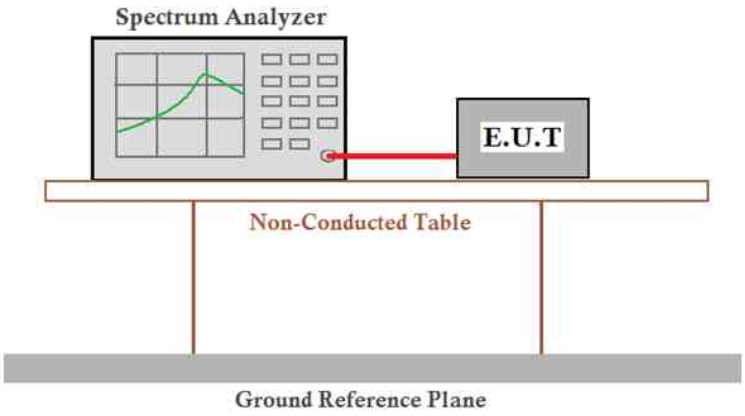
Date: 4.FEB.2021 17:22:21

Test mode:	8DPSK	Test channel:	Middle



Date: 4.FEB.2021 17:21:37

4.7 Hopping Channel Number

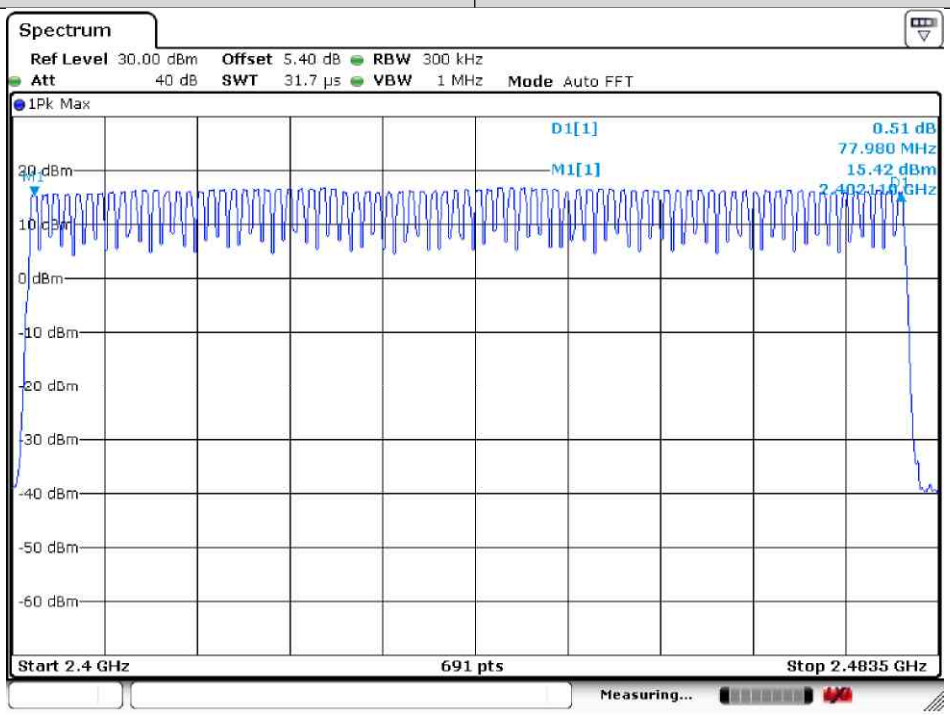
Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.3
Test Setup:	
Instruments Used:	Refer to section 5.10 for details
Test Mode:	Hopping transmitting with all kind of modulation
Limit:	At least 15 channels
Test Results:	Pass

4.7.1 Test Results

Mode	Hopping channel numbers	Limit
GFSK	79	≥15
π/4DQPSK	79	≥15
8DPSK	79	≥15

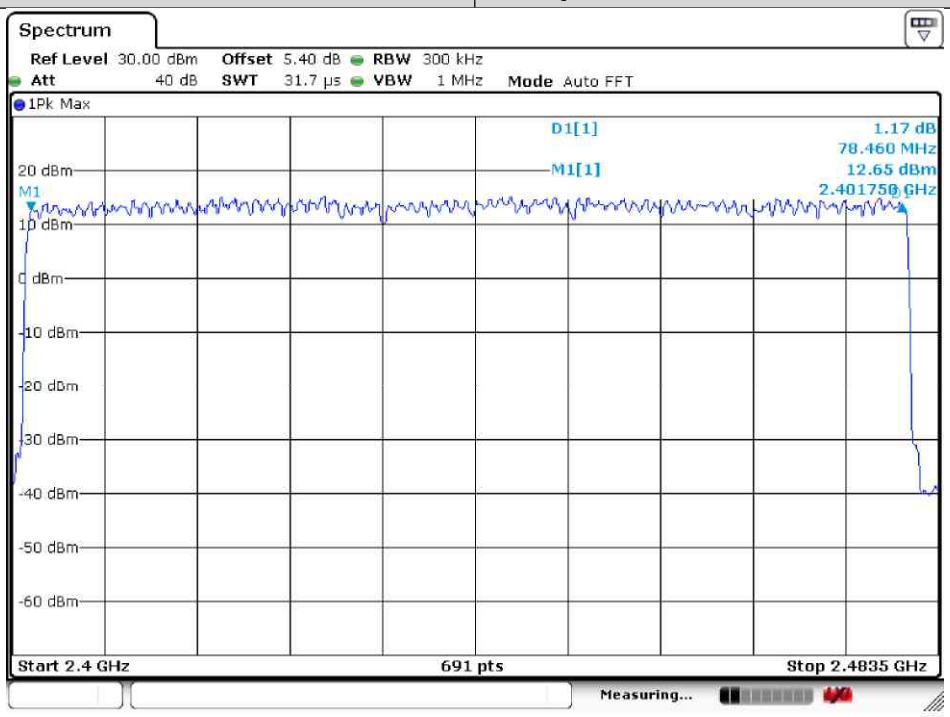
4.7.2 Test Plots

Test mode:	GFSK



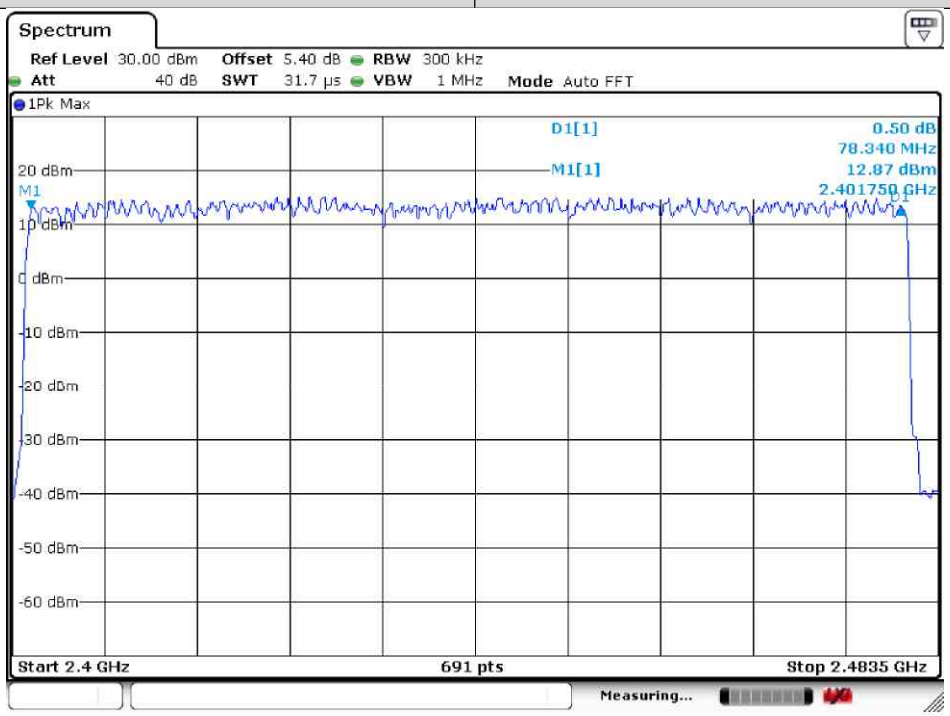
Date: 28.DEC.2020 10:01:38

Test mode:	π/4DQPSK



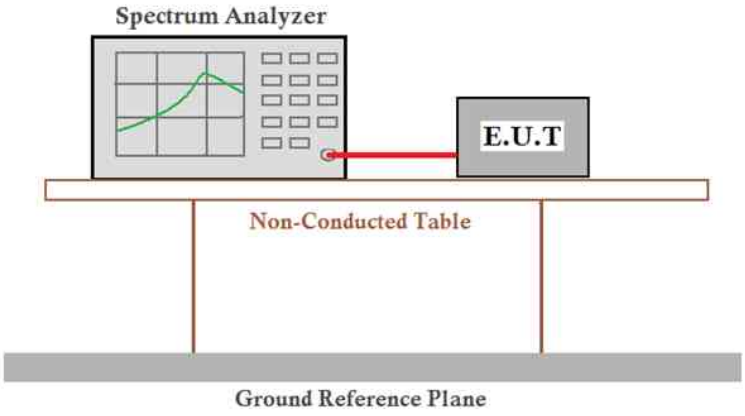
Date: 28.DEC.2020 09:52:39

Test mode:	8DPSK



Date: 28.DEC.2020 10:05:31

4.8 Dwell Time

Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)
Test Method:	ANSI C63.10:2013 Section 7.8.4
Test Setup:	
Instruments Used:	Refer to section 5.10 for details
Test Mode:	Hopping transmitting with all kind of modulation and all kind of data type.
Limit:	0.4 Second
Test Results:	Pass

4.8.1 Test Results

Operation Modes	On time（ms）on one channel
DH1	0.396
DH3	1.654
DH5	2.913
2-DH1	0.399
2-DH3	1.658
2-DH5	2.906
3-DH1	0.399
3-DH2	1.658
3-DH5	2.935

Bluetooth Time of Occupancy Calculation

Typically, Bluetooth 1x/EDR mode has a channel hopping rate of 1600 hops/s, since 1x/EDR modes use 5 transmit and 1 receive slot, for a total of 6 slots, the Bluetooth transmitter is actually hopping at a rate of 1600/6=266.67 hops/slot

400ms x 79 Channel = 31.6 s (Time of Occupancy Limit)

Worst case BT has 266.67 hops/second（for 1x/EDR modes with 3-DH5 operation）

266.67 hops/second/79 channels=3.38 hops/second (# of hops/second on one channel)

3.38 hops/second/channel*31.6seconds=106.67 hops (#hops over a 31.6 second period)

106.67 hops *2.935 ms/channel =313.08 ms(worst case dwell time for one channel in 1x/EDR modes)

With AFH, the number of channels is reduced to a minimum of 20 channels and the channel hopping rate is reduced by 50% to 800hops/s, AFH mode also uses 6 slots so the Bluetooth transmitter hops at a rate of 800/6=133.3 hops/s/slot

400ms x 20 Channel = 8 s (Time of Occupancy Limit)

Worst case BT has 133.3 hops/second/slot (for AFH mode with 3-DH5 operation)

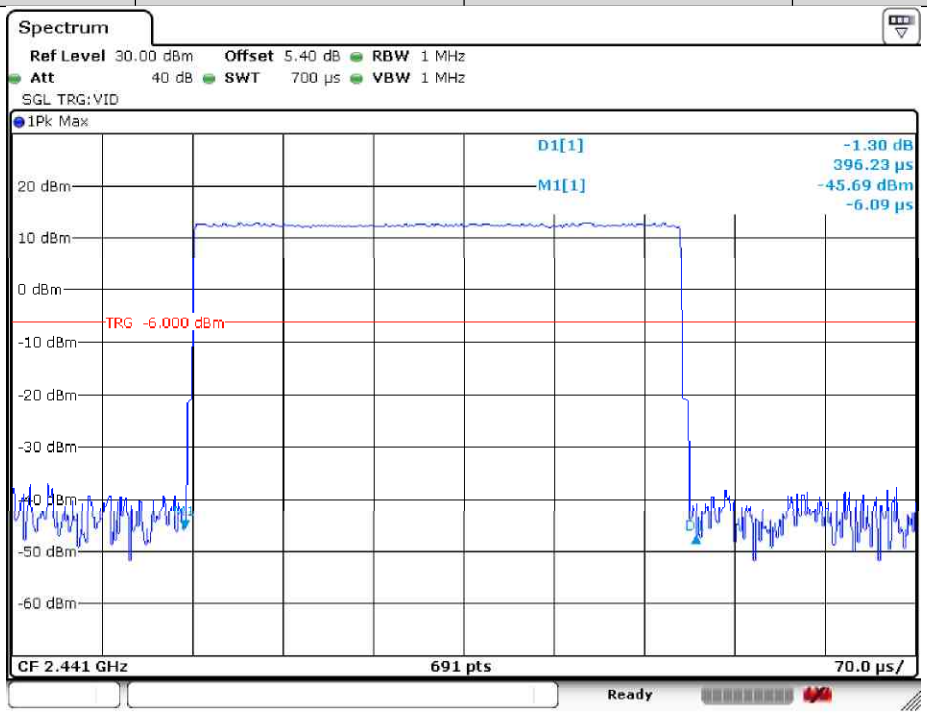
133.3 hops/second/20 channels=6.67 hops/second (#hops/second on one channel)

6.67 hops/second *8seconds=53.34 hops (#hops over a 8 seconds period)

53.34 hops x2.935 ms/channel=156.55 ms(worst case dwell time for one channel in AFH mode)

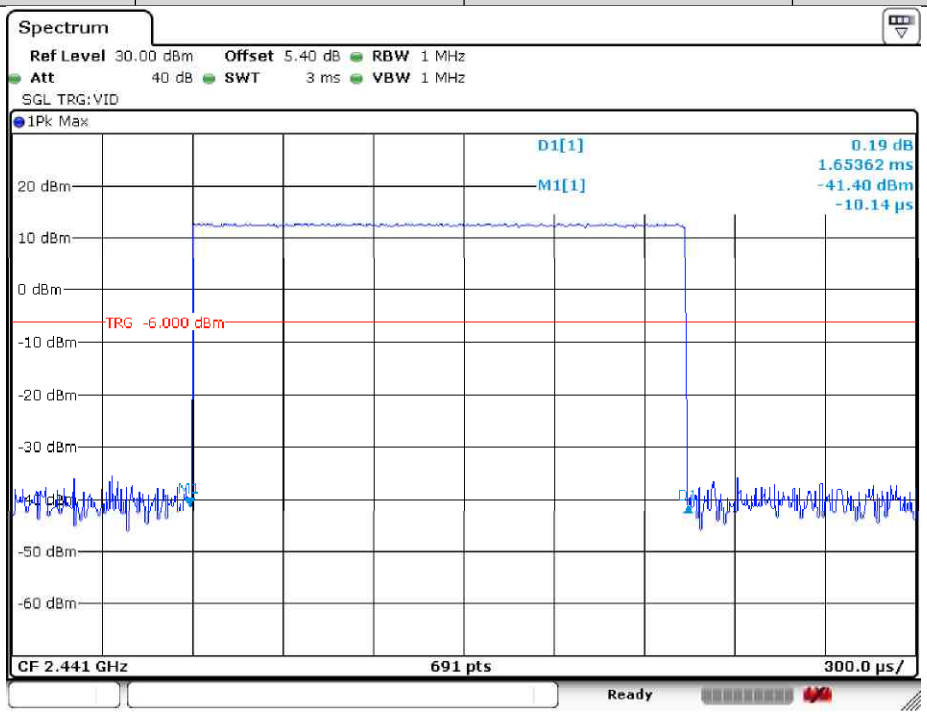
4.8.2 Test Plots

Test mode:	DH1	Test channel:	Middle



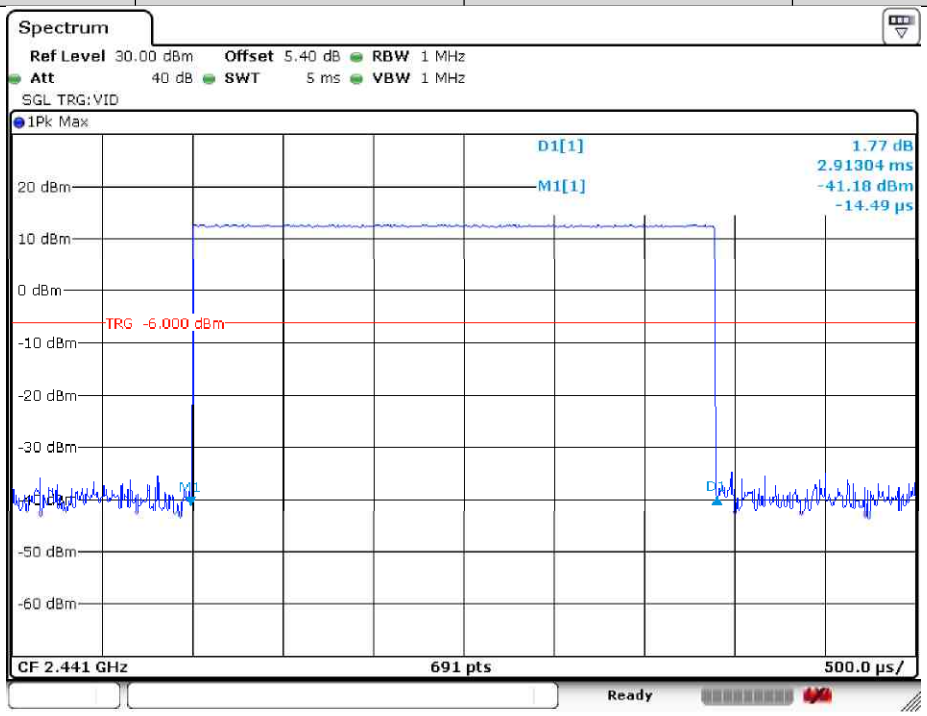
Date: 27.DEC.2020 16:17:34

Test mode:	DH3	Test channel:	Middle



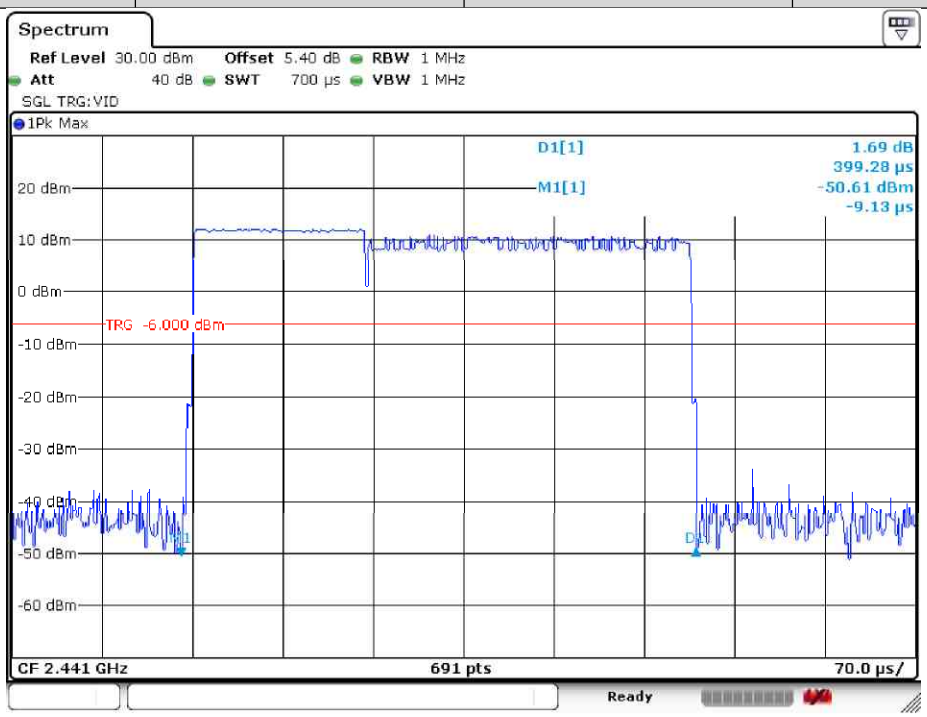
Date: 27.DEC.2020 16:15:57

Test mode:	DH5	Test channel:	Middle



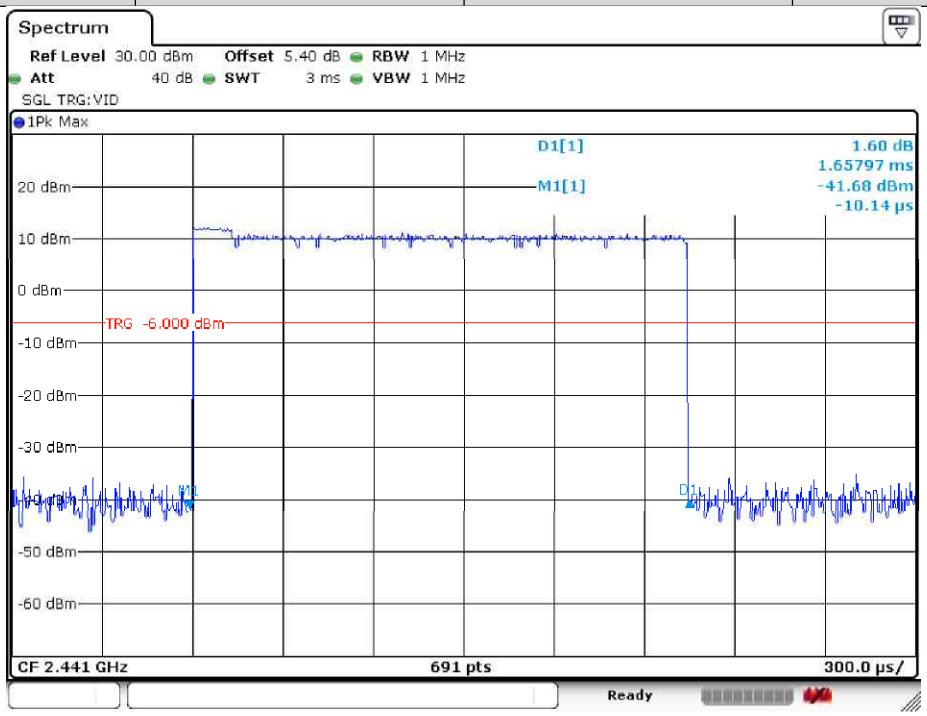
Date: 27.DEC.2020 16:15:35

Test mode:	2-DH1	Test channel:	Middle



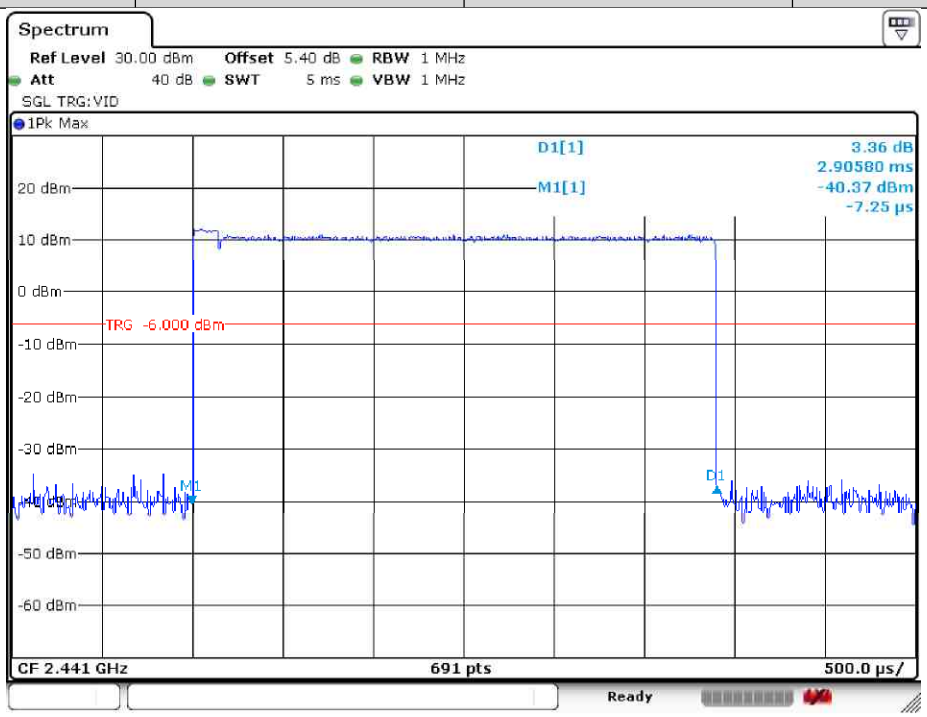
Date: 27.DEC.2020 16:17:10

Test mode:	2-DH3	Test channel:	Middle



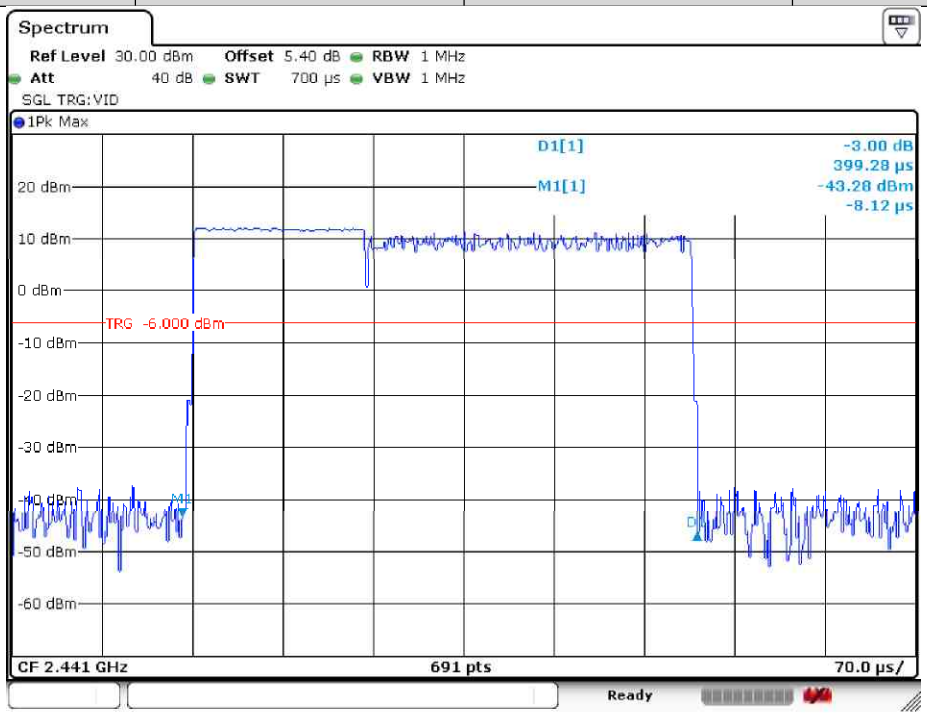
Date: 27.DEC.2020 16:16:17

Test mode:	2-DH5	Test channel:	Middle



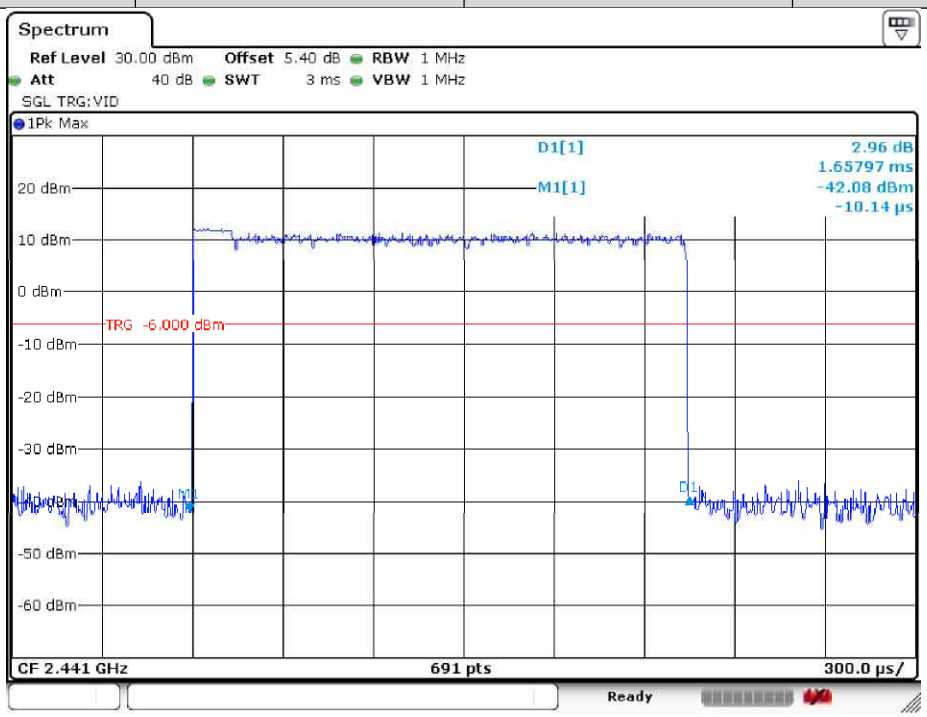
Date: 27.DEC.2020 16:15:16

Test mode:	3-DH1	Test channel:	Middle



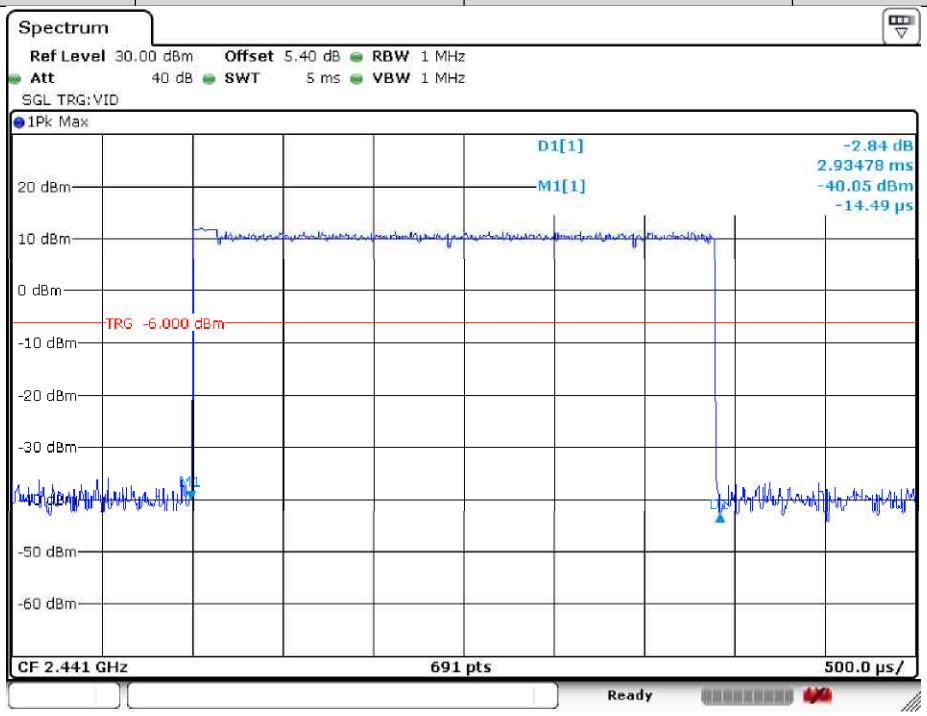
Date: 27.DEC.2020 16:16:57

Test mode:	3-DH3	Test channel:	Middle



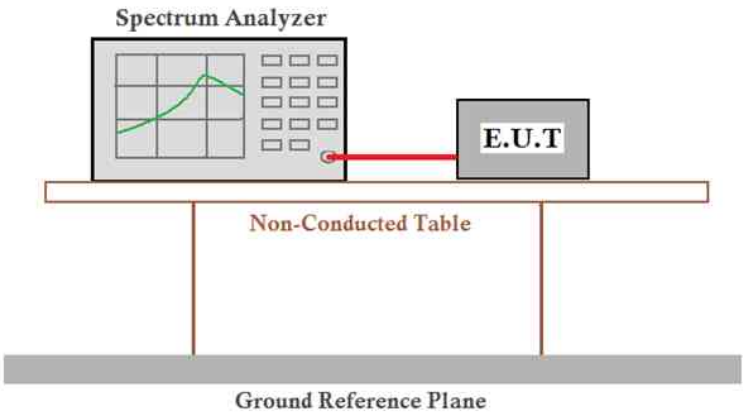
Date: 27.DEC.2020 16:16:33

Test mode:	3-DH5	Test channel:	Middle



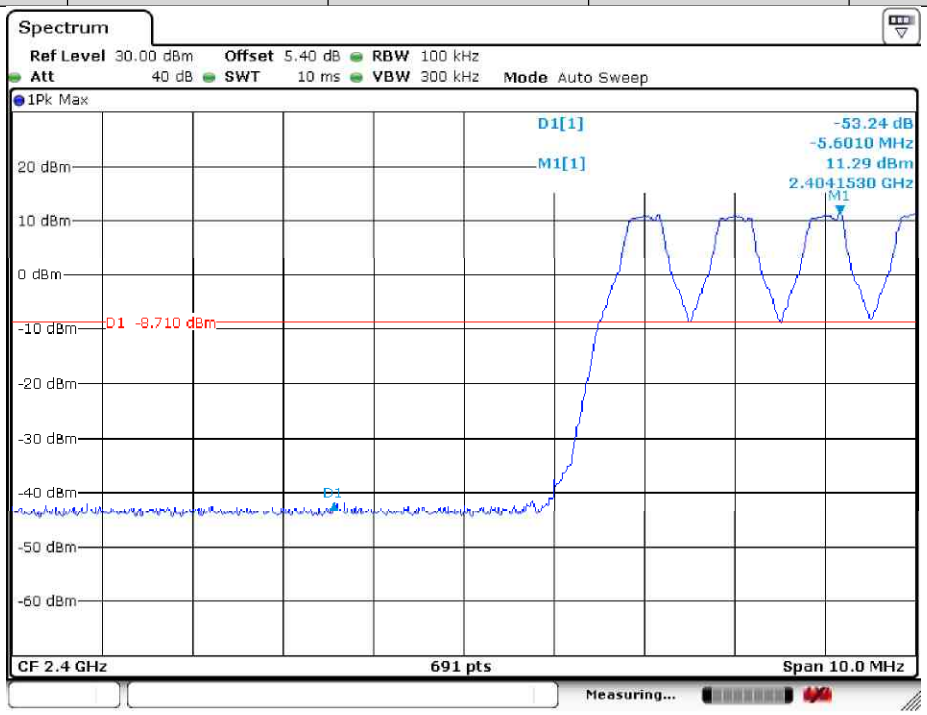
Date: 27.DEC.2020 16:14:56

4.9 Band-edge for RF Conducted Emissions

Test Requirement:	47 CFR Part 15C Section 15.247 (d)
Test Method:	ANSI C63.10:2013 Section 7.8.6
Test Setup:	
Instruments Used:	Refer to section 5.10 for details
Exploratory Test Mode:	Hopping and Non-hopping transmitting with all kind of modulation and all kind of data type.
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.
Test Results:	Pass

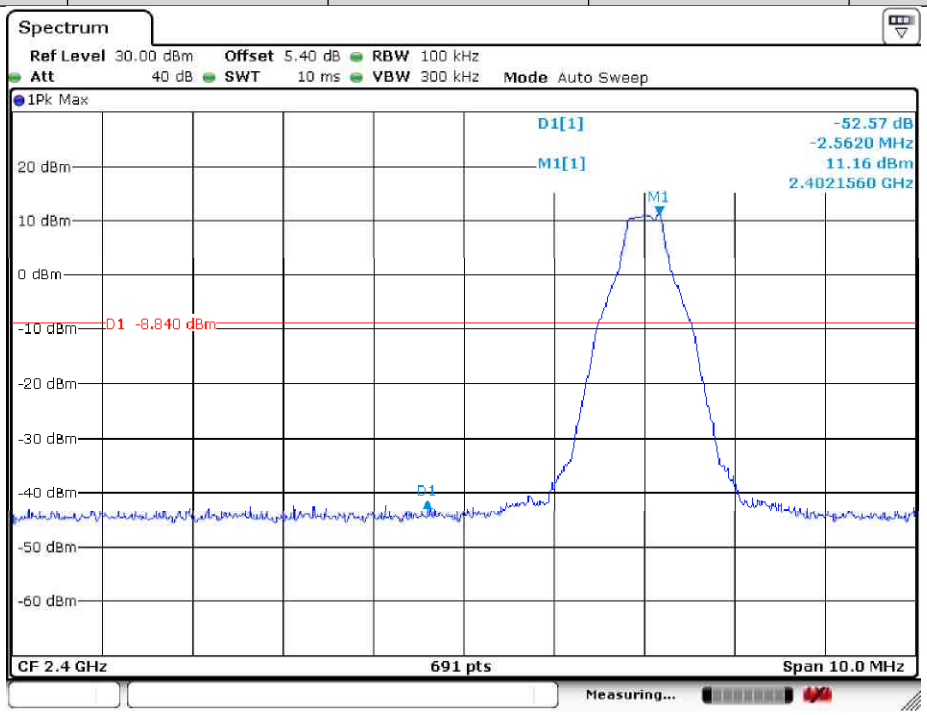
4.9.1 Test Plots

Test mode:	GFSK	Test channel:	Lowest	Hopping ON



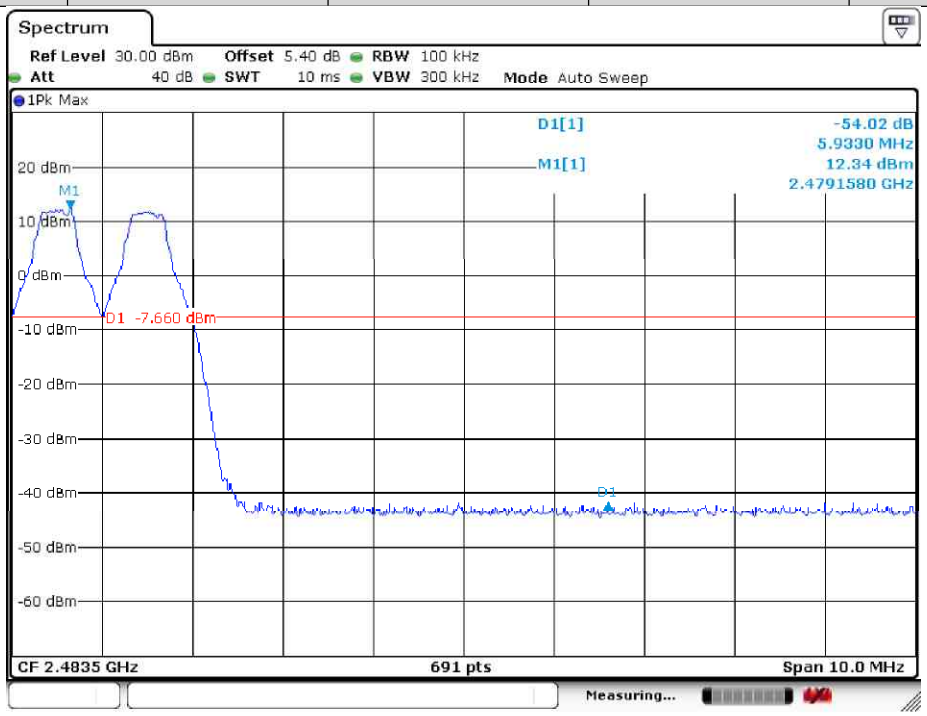
Date: 27.DEC.2020 16:04:53

Test mode:	GFSK	Test channel:	Lowest	Hopping OFF



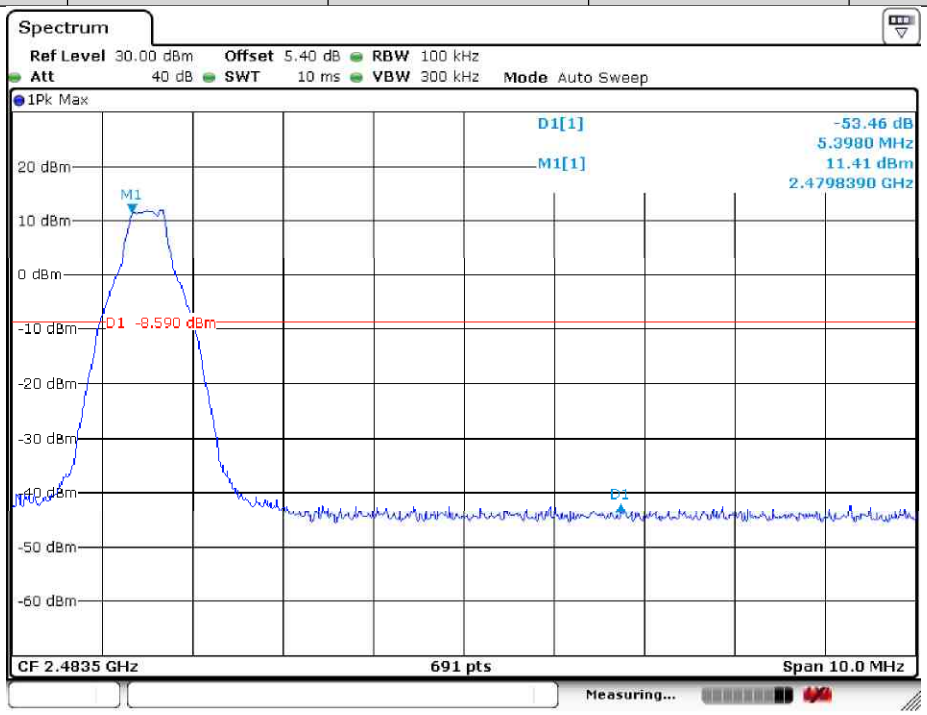
Date: 27.DEC.2020 16:01:27

Test mode:	GFSK	Test channel:	Highest	Hopping ON



Date: 27.DEC.2020 16:06:42

Test mode:	GFSK	Test channel:	Highest	Hopping OFF

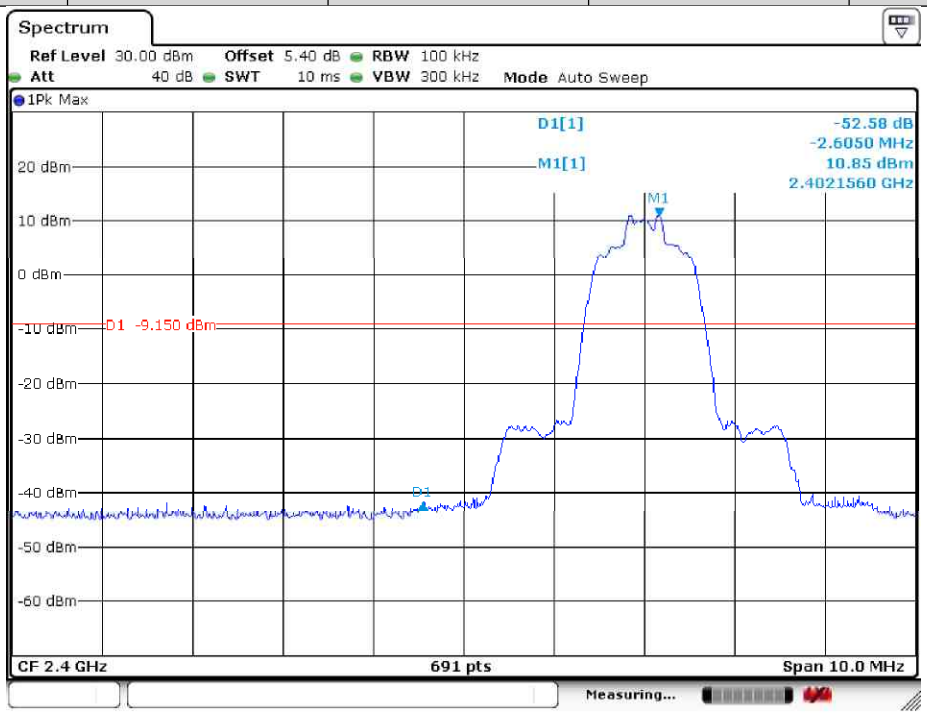


Date: 27.DEC.2020 16:00:44

Test mode:	π/4DQPSK	Test channel:	Lowest	Hopping ON

Date: 27.DEC.2020 16:08:16

Test mode:	π/4DQPSK	Test channel:	Lowest	Hopping OFF



Date: 27.DEC.2020 15:59:17

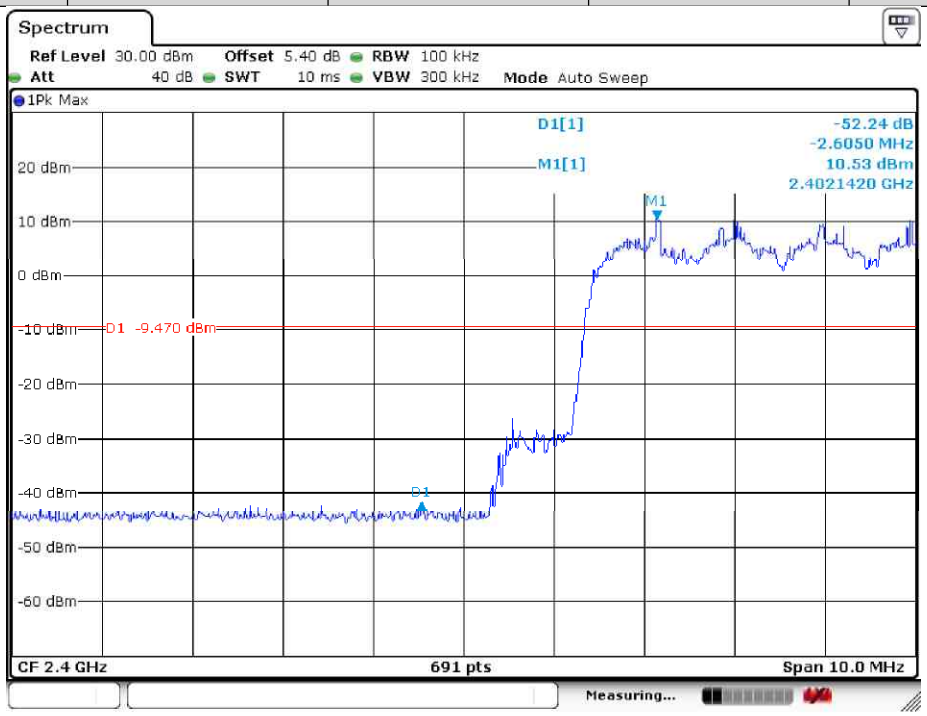
Test mode:	π/4DQPSK	Test channel:	Highest	Hopping ON

Date: 27.DEC.2020 16:07:35

Test mode:	π/4DQPSK	Test channel:	Highest	Hopping OFF

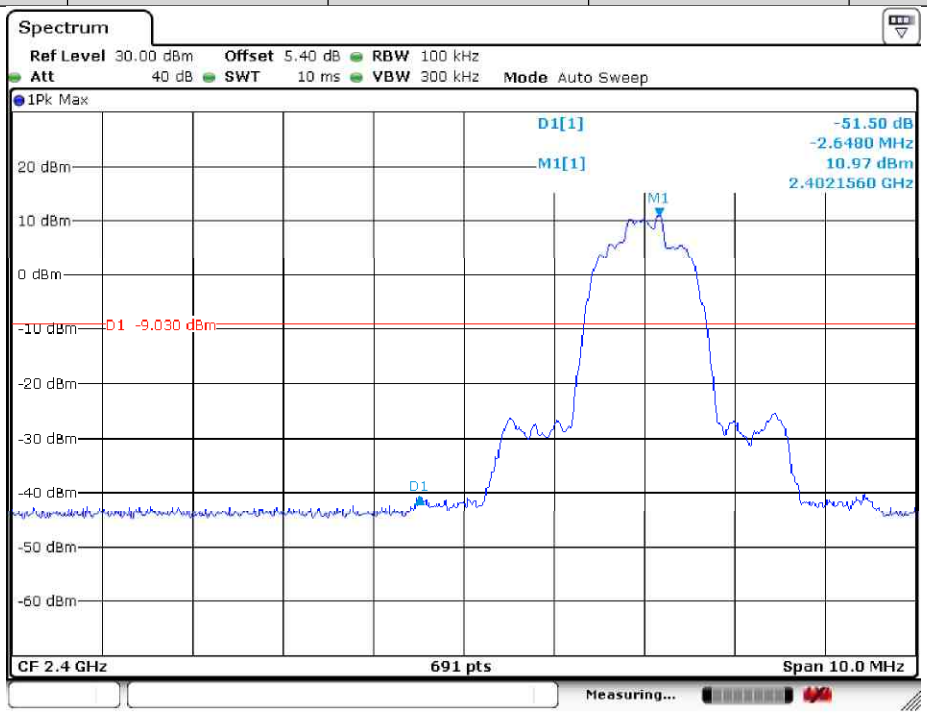
Date: 27.DEC.2020 16:00:16

Test mode:	8DPSK	Test channel:	Lowest	Hopping ON



Date: 27.DEC.2020 16:08:54

Test mode:	8DPSK	Test channel:	Lowest	Hopping OFF



Date: 27.DEC.2020 15:58:22

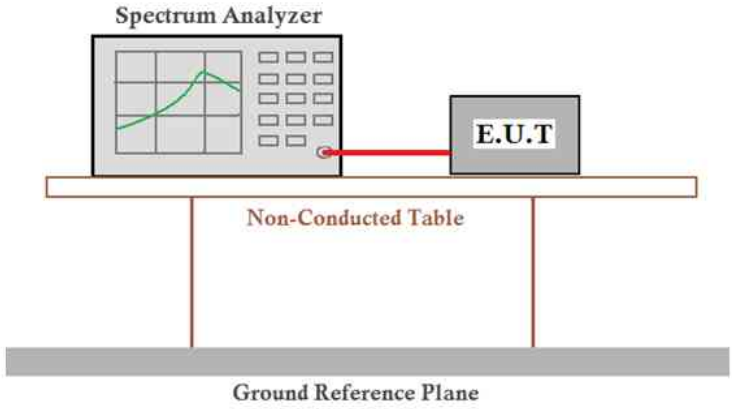
Test mode:	8DPSK	Test channel:	Highest	Hopping ON

Date: 27.DEC.2020 16:09:53

Test mode:	8DPSK	Test channel:	Highest	Hopping OFF

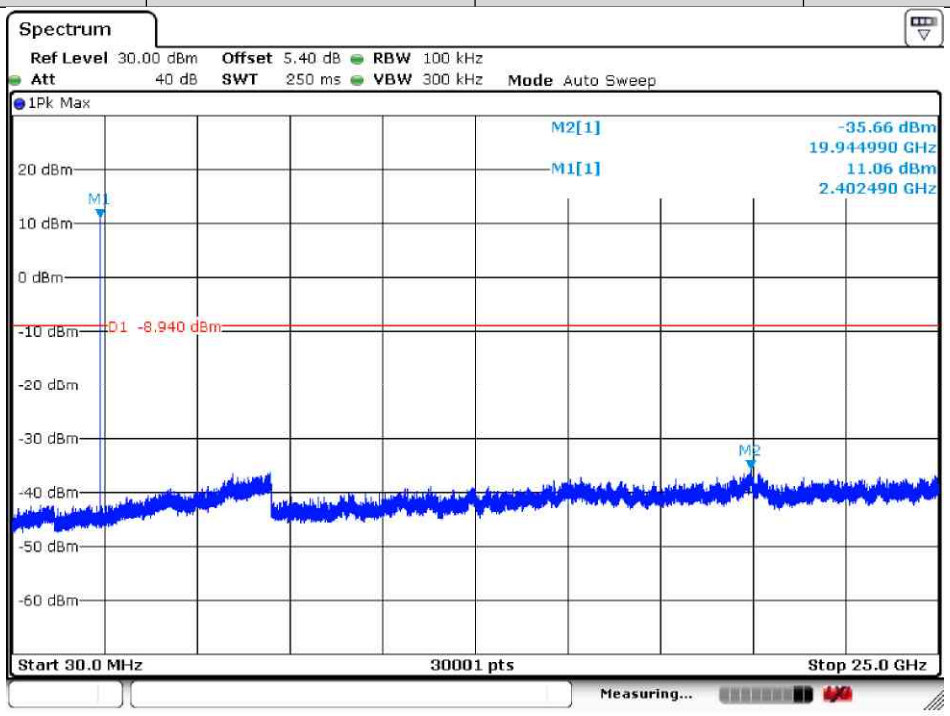
Date: 27.DEC.2020 15:57:01

4.10 Spurious RF Conducted Emissions

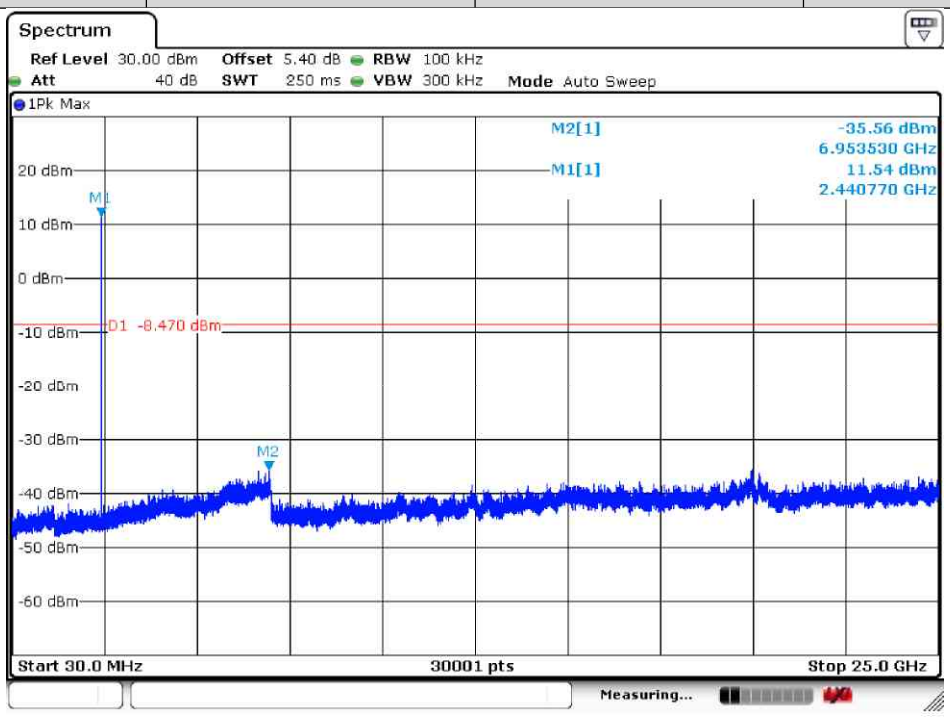
Test Requirement:	47 CFR Part 15C Section 15.247 (d)
Test Method:	ANSI C63.10:2013 Section 7.8.8
Test Setup:	
Instruments Used:	Refer to section 5.10 for details
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type.
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.
Test Results:	Pass

4.10.1 Test Plots

Test mode:	GFSK	Test channel:	Lowest

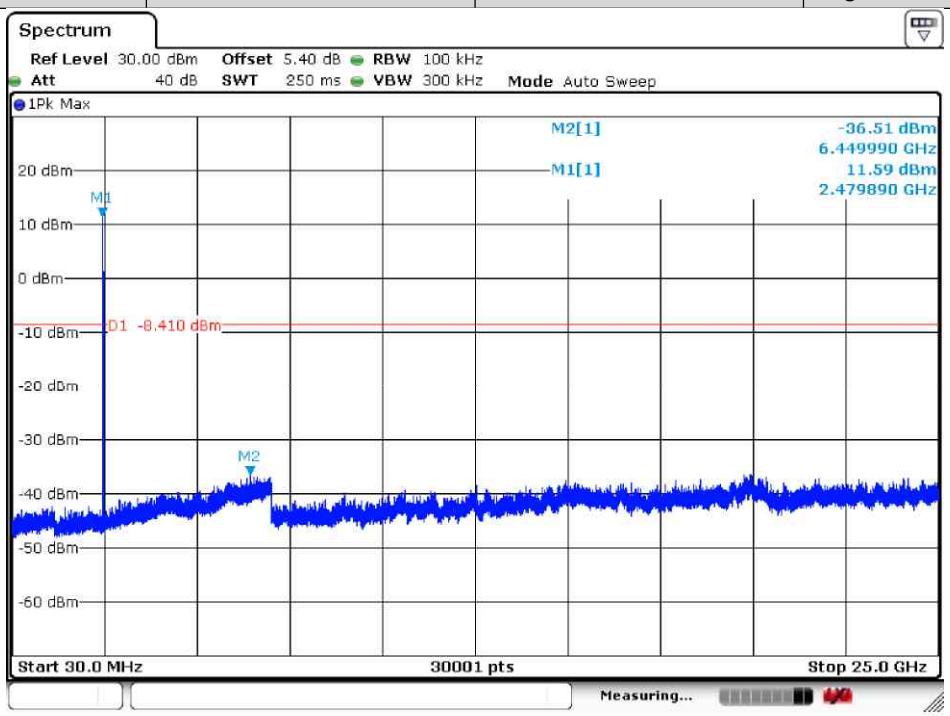


Test mode:	GFSK	Test channel:	Middle



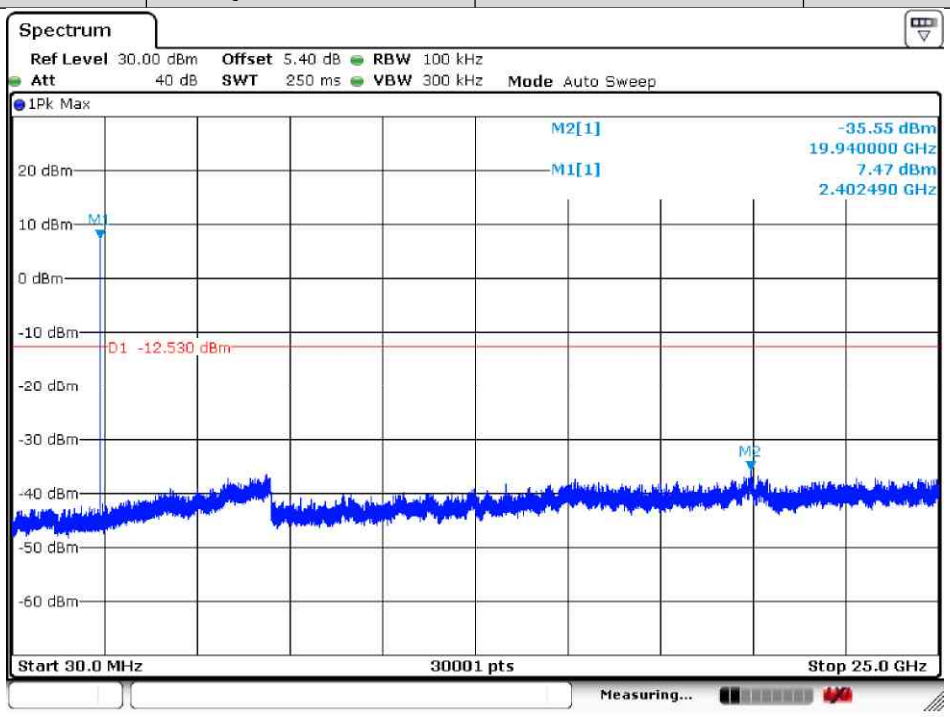
Date: 7.DEC.2020 11:49:19

Test mode:	GFSK	Test channel:	Highest



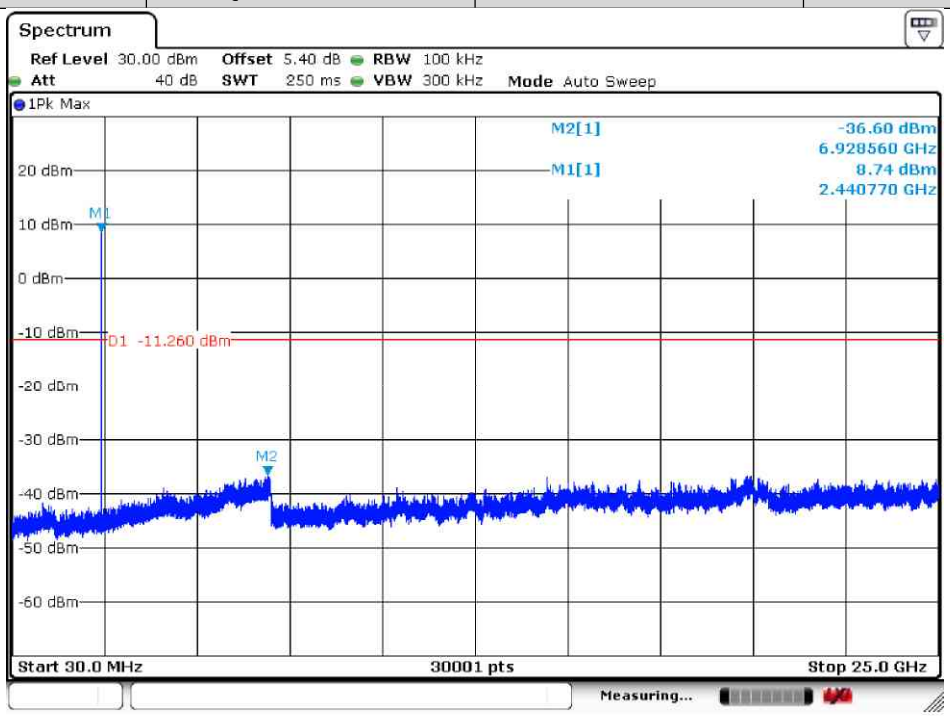
Date: 7.DEC.2020 11:50:14

Test mode:	π/4DQPSK	Test channel:	Lowest



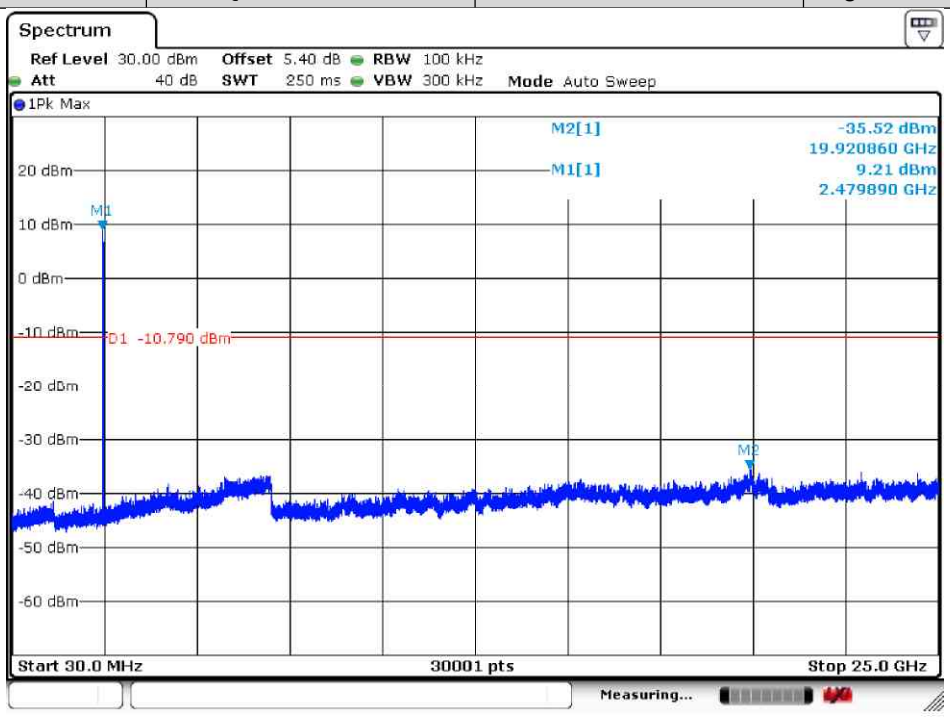
Date: 7.DEC.2020 11:46:06

Test mode:	π/4DQPSK	Test channel:	Middle



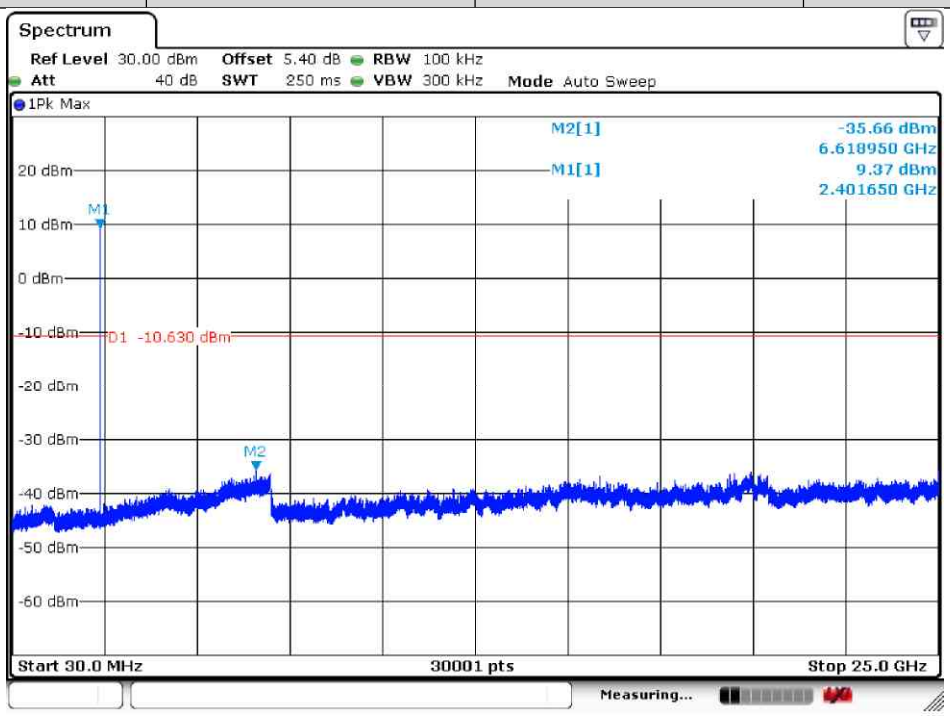
Date: 7.DEC.2020 11:45:05

Test mode:	π/4DQPSK	Test channel:	Highest



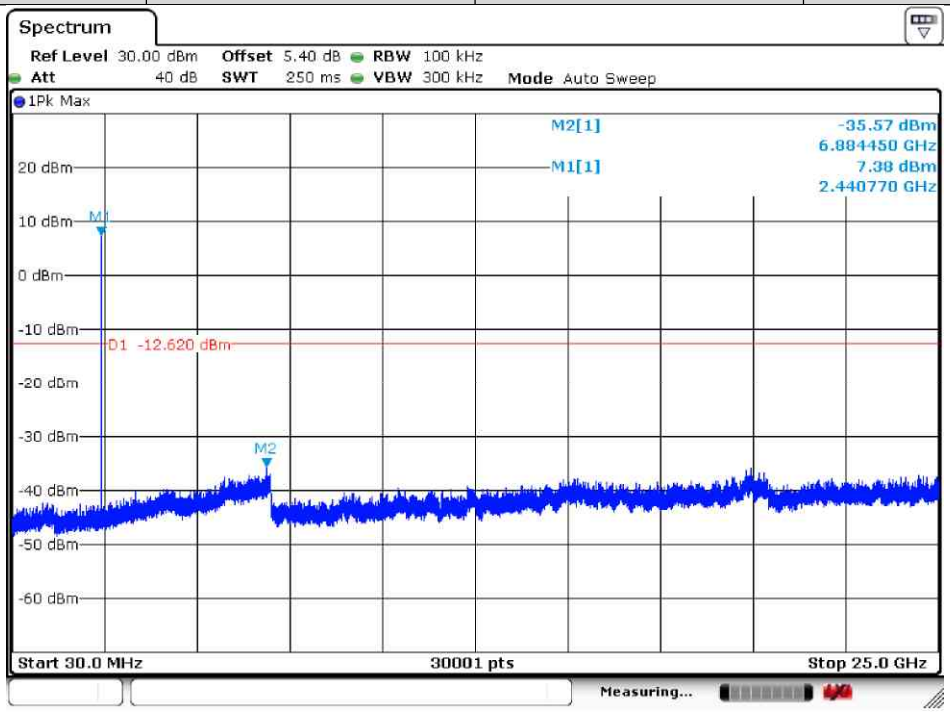
Date: 7.DEC.2020 11:44:15

Test mode:	8DPSK	Test channel:	Lowest



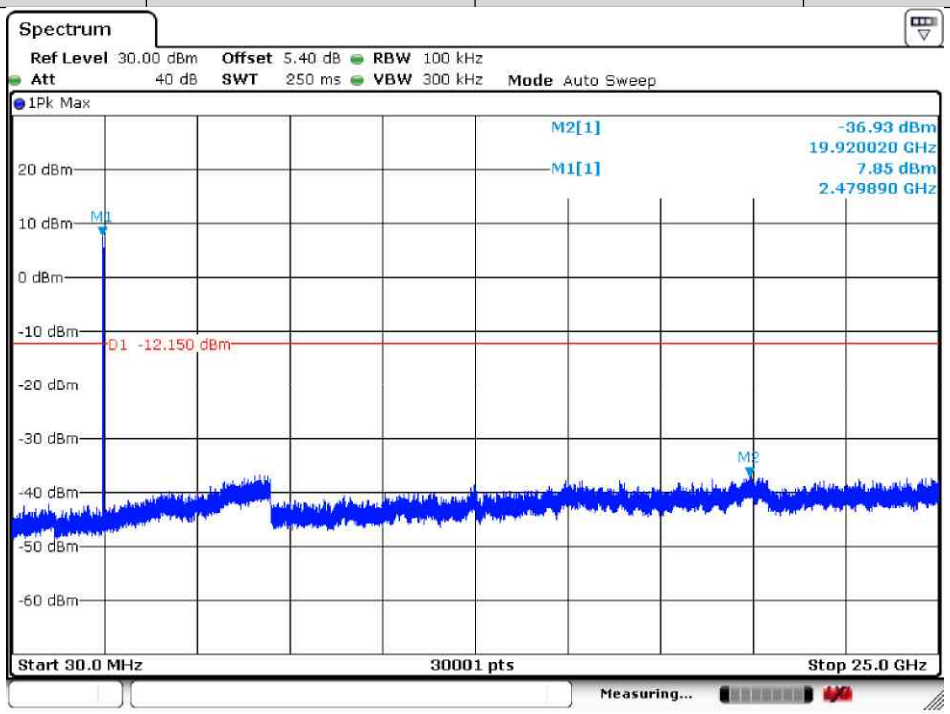
Date: 7.DEC.2020 11:39:41

Test mode:	8DPSK	Test channel:	Middle



Date: 7.DEC.2020 11:40:35

Test mode:	8DPSK	Test channel:	Highest



Date: 7.DEC.2020 11:41:12

Remark:

Scan from 9kHz to 25GHz, the disturbance between 9KHz to 30MHz was very low, and the above harmonics were the highest point could be found when testing, The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

4.11 Radiated Spurious Emissions

Test Requirement:	47 CFR Part 15C Section 15.209 and 15.205				
Test Method:	ANSI C63.10 :2013 Section 11.12				
Test Site:	Measurement Distance: 3m (Semi-Anechoic Chamber)				
Receiver Setup:	Frequency	Detector	RBW	VBW	Remark
	0.009MHz-0.090MHz	Peak	10kHz	30kHz	Peak
	0.009MHz-0.090MHz	Average	10kHz	30kHz	Average
	0.090MHz-0.110MHz	Quasi-peak	10kHz	30kHz	Quasi-peak
	0.110MHz-0.490MHz	Peak	10kHz	30kHz	Peak
	0.110MHz-0.490MHz	Average	10kHz	30kHz	Average
	0.490MHz -30MHz	Quasi-peak	10kHz	30kHz	Quasi-peak
	30MHz-1GHz	Quasi-peak	120kHz	300kHz	Quasi-peak
	Above 1GHz	Peak	1MHz	3MHz	Peak
		Peak	1MHz	10Hz	Average
Limit:	Frequency	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz-0.490MHz	2400/F(kHz)	-	-	300
	0.490MHz-1.705MHz	24000/F(kHz)	-	-	30
	1.705MHz-30MHz	30	-	-	30
	30MHz-88MHz	100	40.0	Quasi-peak	3
	88MHz-216MHz	150	43.5	Quasi-peak	3
	216MHz-960MHz	200	46.0	Quasi-peak	3
	960MHz-1GHz	500	54.0	Quasi-peak	3
	Above 1GHz	500	54.0	Average	3
	Remark: 15.35(b),Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.				

Test Setup:	

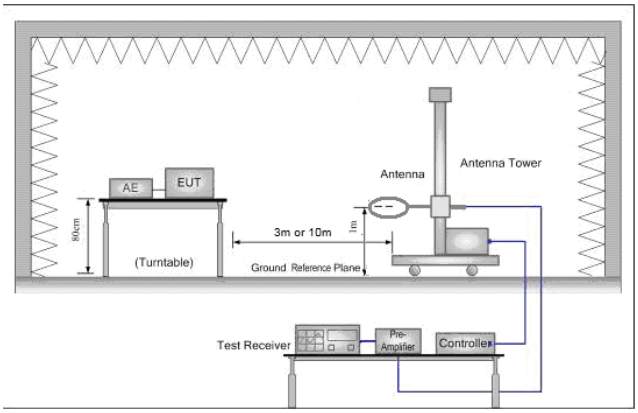


Figure 1. Below 30MHz

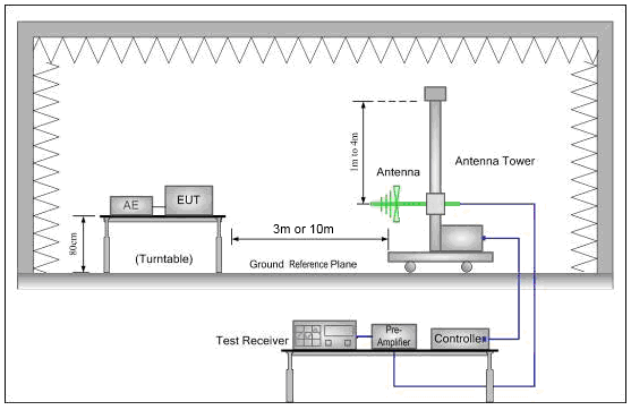


Figure 2. 30MHz to 1GHz

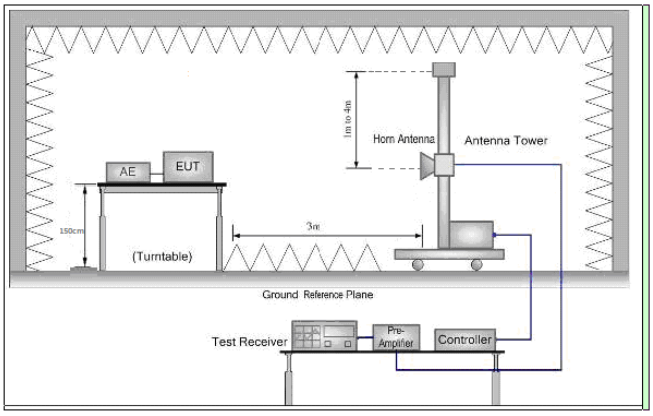


Figure 3. Above 1 GHz

Test Procedure:	a. For below 1GHz, the EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 or 10 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation. b. For above 1GHz, the EUT was placed on the top of a rotating table 1.5 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation c. The EUT was set 3 or 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower. d. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement. e. Use the following spectrum analyzer settings: (1) Span shall wide enough to fully capture the emission being measured; (2) Set RBW=100 kHz for f < 1 GHz, RBW=1MHz for f>1GHz ; VBW ≥ RBW; Sweep = auto; Detector function = peak; Trace = max hold for peak (3) For average measurement: use duty cycle correction factor method per 15.35(c).

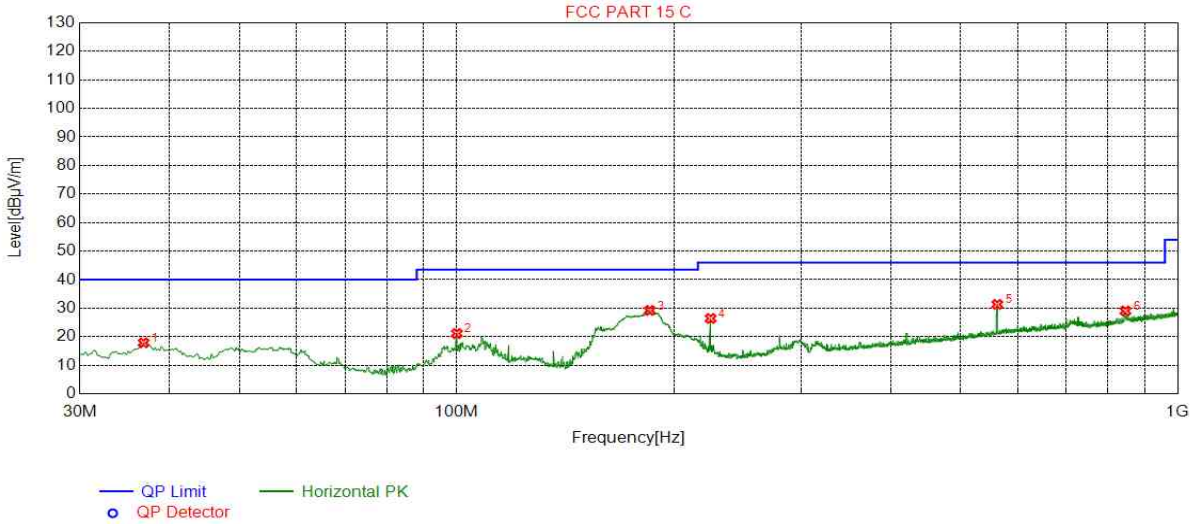
	Duty cycle = On time/100 milliseconds On time = N 1 *L 1 +N 2 *L 2 +...+N n-1 *LN n-1 +N n *L n Where N 1 is number of type 1 pulses, L 1 is length of type 1 pulses, etc. Average Emission Level = Peak Emission Level + 20*log(Duty cycle) f. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters(for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading. g. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode. h. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet. i. Test the EUT in the lowest channel, the middle channel ,the Highest channel. j. The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, And found the X axis positioning which it is worse case. k. Repeat above procedures until all frequencies measured was complete.
Exploratory Test Mode:	Non-hopping transmitting mode with all kind of modulation and all kind of data type Charge + Transmitting mode.
Final Test Mode:	Through Pre-scan, find the DH5 of data type and GFSK modulation is the worst case. Pretest the EUT at Charge + Transmitting mode For below 1GHz part, through pre-scan, the worst case is the lowest channel. Only the worst case is recorded in the report.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass

4.11.1 Radiated Emission below 1GHz

4.11.2 Radiated Emission below 1GHz

4.11.2.1 Charge + Transmitting

Test Graph

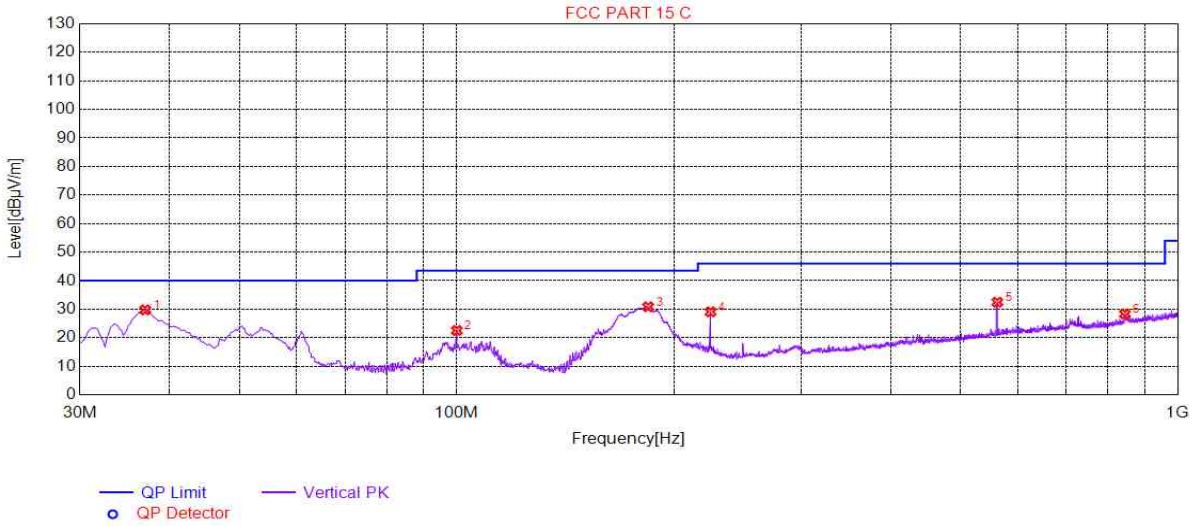


Suspected List

Suspected List							
NO.	Freq. [MHz]	Level [dBμV/m]	Limit [dBμV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	36.7914	17.89	40.00	22.11	200	264	Horizontal
2	100.0480	21.14	43.50	22.36	200	123	Horizontal
3	185.2310	29.23	43.50	14.27	100	261	Horizontal
4	225.0090	26.43	46.00	19.57	200	235	Horizontal
5	562.0544	31.35	46.00	14.65	200	44	Horizontal
6	846.3213	29.07	46.00	16.93	100	340	Horizontal

Final Data List

Test Graph



Suspected List

Suspected List							
NO.	Freq. [MHz]	Level [dBµV/m]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	36.9854	29.79	40.00	10.21	100	346	Vertical
2	100.0480	22.55	43.50	20.95	200	76	Vertical
3	184.2609	30.87	43.50	12.63	100	360	Vertical
4	225.0090	29.09	46.00	16.91	100	67	Vertical
5	562.0544	32.48	46.00	13.52	200	346	Vertical
6	844.9630	28.35	46.00	17.65	200	120	Vertical

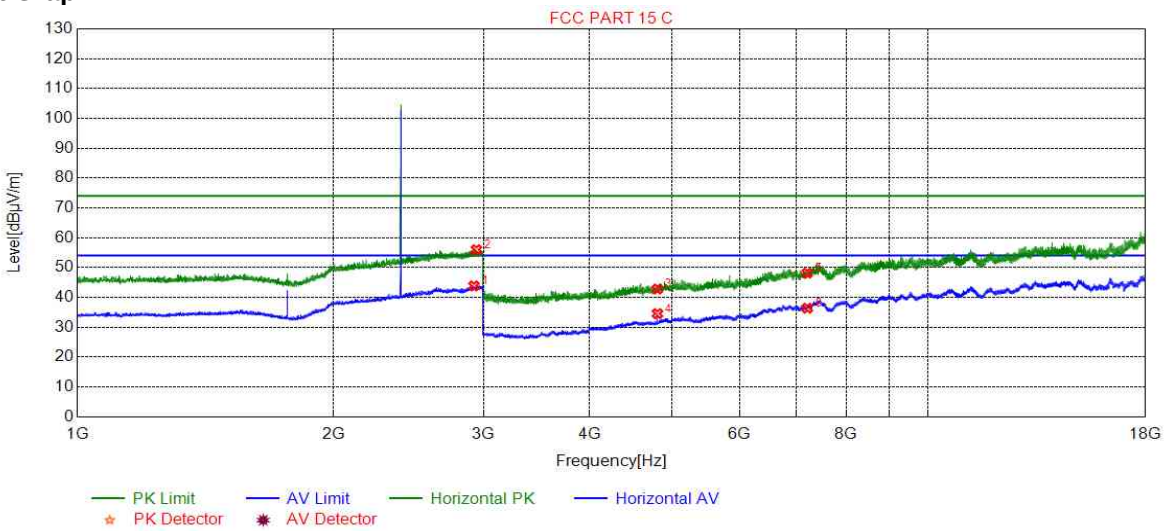
Final Data List

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch
No.1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, China 518057 t (86-755) 26012053 f (86-755) 26710594 www.sgsgroup.com.cn
中国·深圳·科技园中区M-10栋一号厂房 邮编: 518057 t (86-755) 26012053 f (86-755) 26710594 sgs.china@sgs.com

4.11.3 Transmitter Emission above 1GHz

4.11.3.1 GFSK_Channel 0

Test Graph



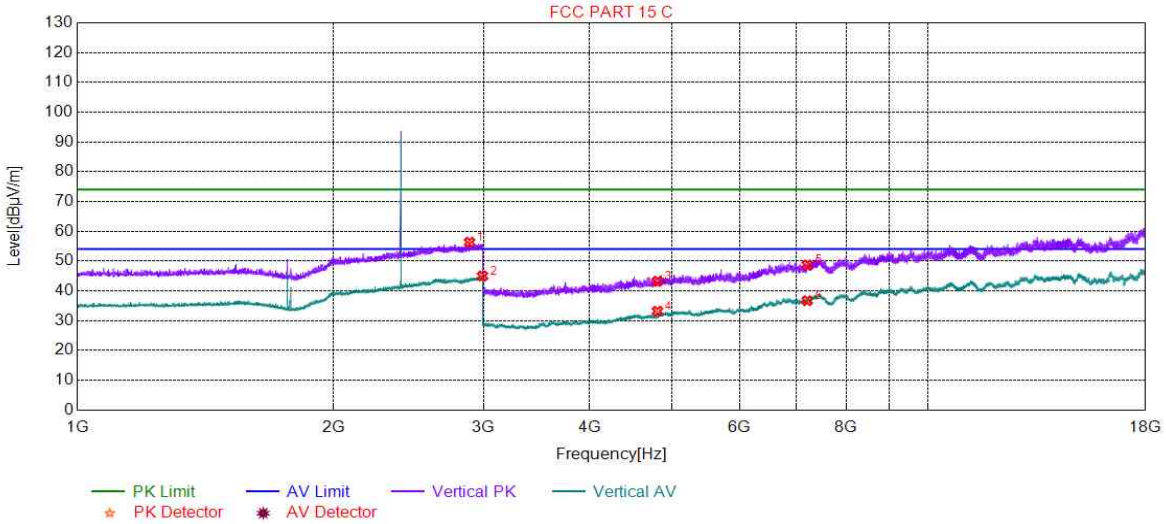
Suspected List

Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2923.98	43.83	10.61	54.00	10.17	150	164	Horizontal
2	2943.98	55.98	10.61	74.00	18.02	150	92	Horizontal
3	4804.00	42.79	-17.18	74.00	31.21	150	268	Horizontal
4	4804.00	34.54	-17.18	54.00	19.46	150	286	Horizontal
5	7206.00	48.13	-9.48	74.00	25.87	150	323	Horizontal
6	7206.00	36.35	-9.48	54.00	17.65	150	34	Horizontal

Final Data List

4.11.3.2 GFSK_Channel 0

Test Graph



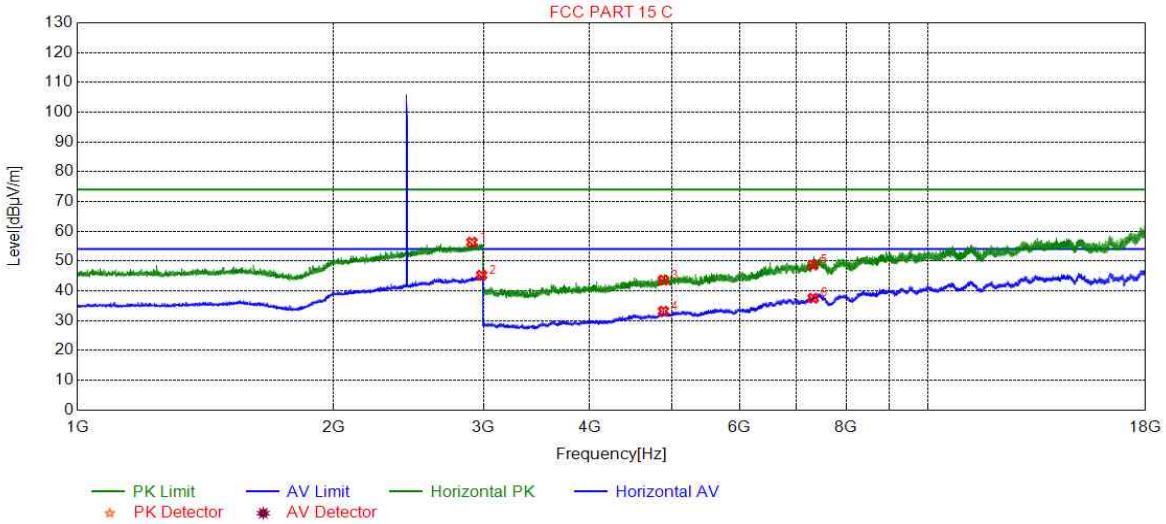
Suspected List

Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2889.97	56.31	10.41	74.00	17.69	150	272	Vertical
2	2992.99	44.96	10.64	54.00	9.04	150	225	Vertical
3	4804.00	43.18	-17.18	74.00	30.82	150	334	Vertical
4	4804.00	33.15	-17.18	54.00	20.85	150	275	Vertical
5	7206.00	48.69	-9.48	74.00	25.31	150	275	Vertical
6	7206.00	36.67	-9.48	54.00	17.33	150	54	Vertical

Final Data List

4.11.3.3 GFSK_Channel 39

Test Graph



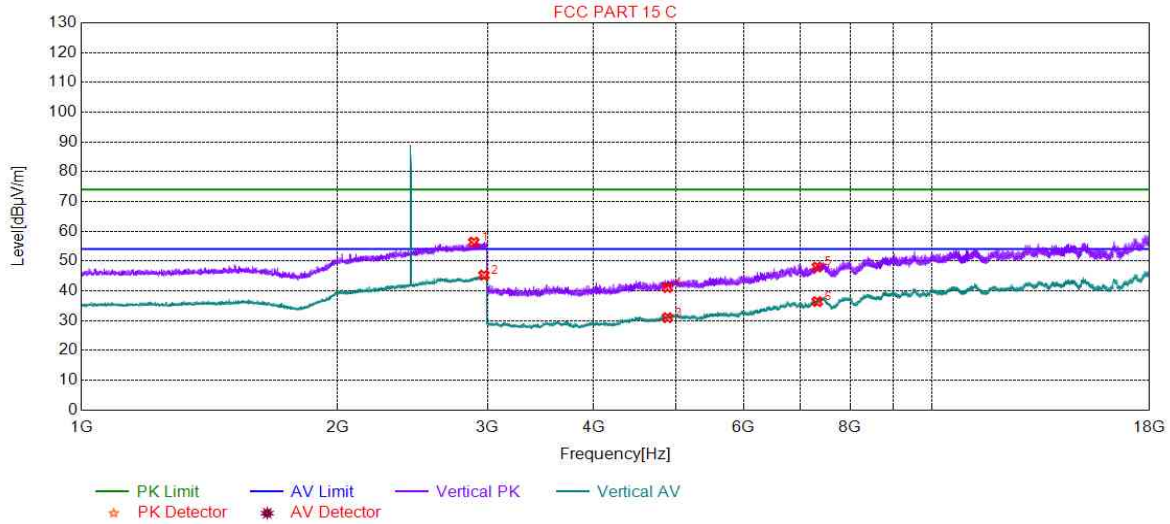
Suspected List

Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2908.47	56.29	10.48	74.00	17.71	150	130	Horizontal
2	2985.49	45.23	10.60	54.00	8.77	150	345	Horizontal
3	4882.00	43.61	-16.80	74.00	30.39	150	282	Horizontal
4	4882.00	33.16	-16.80	54.00	20.84	150	325	Horizontal
5	7323.00	48.62	-9.27	74.00	25.38	150	38	Horizontal
6	7323.00	37.51	-9.27	54.00	16.49	150	198	Horizontal

Final Data List

4.11.3.4 GFSK_Channel 39

Test Graph



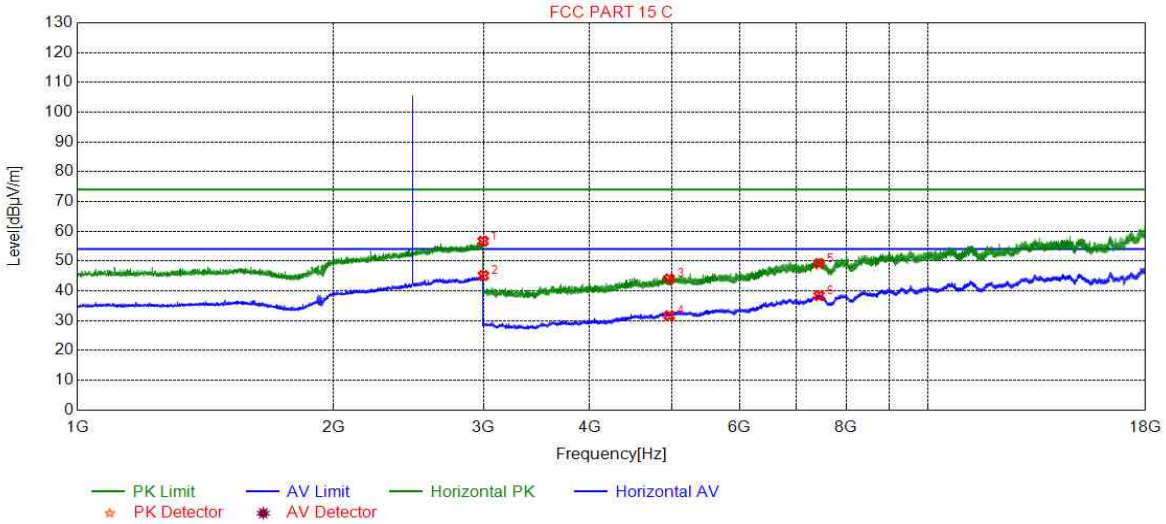
Suspected List

Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2891.47	56.33	10.41	74.00	17.67	150	326	Vertical
2	2972.49	45.22	10.60	54.00	8.78	150	263	Vertical
3	4882.00	30.96	-16.80	54.00	23.04	150	118	Vertical
4	4882.00	41.11	-16.80	74.00	32.89	150	118	Vertical
5	7323.00	47.97	-9.27	74.00	26.03	150	221	Vertical
6	7323.00	36.37	-9.27	54.00	17.63	150	258	Vertical

Final Data List

4.11.3.5 GFSK_Channel 78

Test Graph



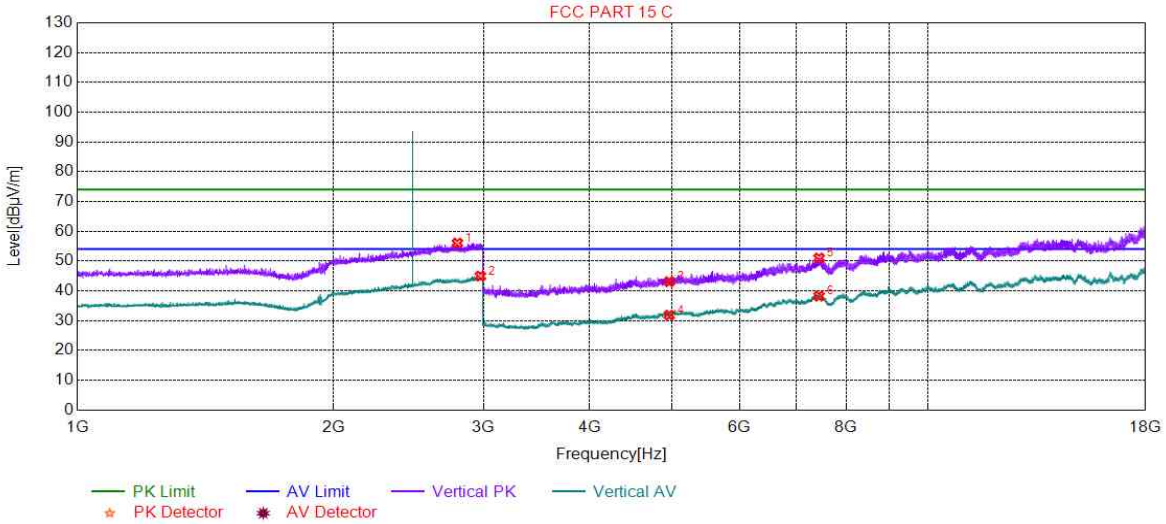
Suspected List

Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2997.49	56.65	10.74	74.00	17.35	150	301	Horizontal
2	3000.00	45.12	10.78	54.00	8.88	150	242	Horizontal
3	4960.00	44.05	-16.28	74.00	29.95	150	169	Horizontal
4	4960.00	31.63	-16.28	54.00	22.37	150	290	Horizontal
5	7440.00	49.19	-8.83	74.00	24.81	150	290	Horizontal
6	7440.00	38.33	-8.83	54.00	15.67	150	268	Horizontal

Final Data List

4.11.3.6 GFSK_Channel 78

Test Graph



Suspected List

Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2796.44	56.02	9.90	74.00	17.98	150	283	Vertical
2	2975.99	44.92	10.57	54.00	9.08	150	192	Vertical
3	4960.00	43.05	-16.28	74.00	30.95	150	120	Vertical
4	4960.00	31.82	-16.28	54.00	22.18	150	50	Vertical
5	7440.00	50.99	-8.83	74.00	23.01	150	50	Vertical
6	7440.00	38.21	-8.83	54.00	15.79	150	192	Vertical

Final Data List

Remark:
1) The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows:
Final Test Level =Receiver Reading + Antenna Factor + Cable Factor – Preamplifier Factor

2) Scan from 9kHz to 25GHz, the disturbance between 9KHz to 30MHz and 18GHz to 25GHz was very low, and the above harmonics were the highest point could be found when testing, The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

3)As shown in this section, for frequencies above 1GHz, the field strength limits are based on average limits. However, the peak field strength of any emission shall not exceed the maximum permitted average limits specified above by more than 20 dB under any condition of modulation. So, only the peak measurements were shown in the report.

4）All Modes have been tested, but only the worst case data displayed in this report.

4.12Restricted bands around fundamental frequency

Test Requirement:	47 CFR Part 15C Section 15.209 and 15.205		
Test Method:	ANSI C63.10: 2013		
Test Site:	Measurement Distance: 3m (Semi-Anechoic Chamber)		
Limit:	Frequency	Limit (dBuV/m)	Remark
	30MHz-88MHz	40.0	Quasi-peak
	88MHz-216MHz	43.5	Quasi-peak
	216MHz-960MHz	46.0	Quasi-peak
	960MHz-1GHz	54.0	Quasi-peak
	Above 1GHz	54.0	Average Value
		74.0	Peak Value
Test Setup:			

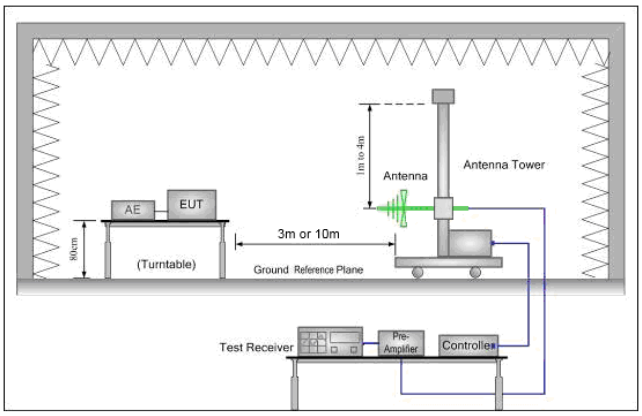


Figure 1. 30MHz to 1GHz

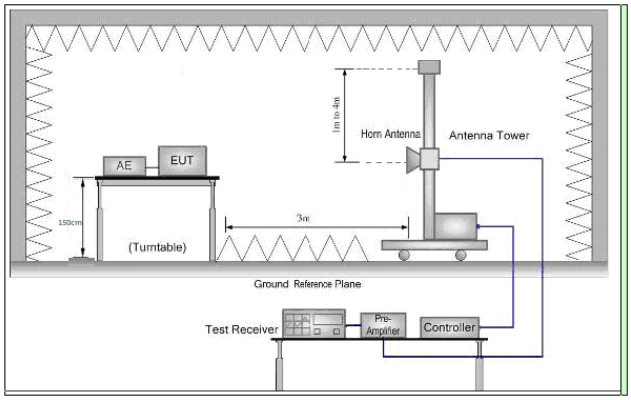


Figure 2. Above 1 GHz

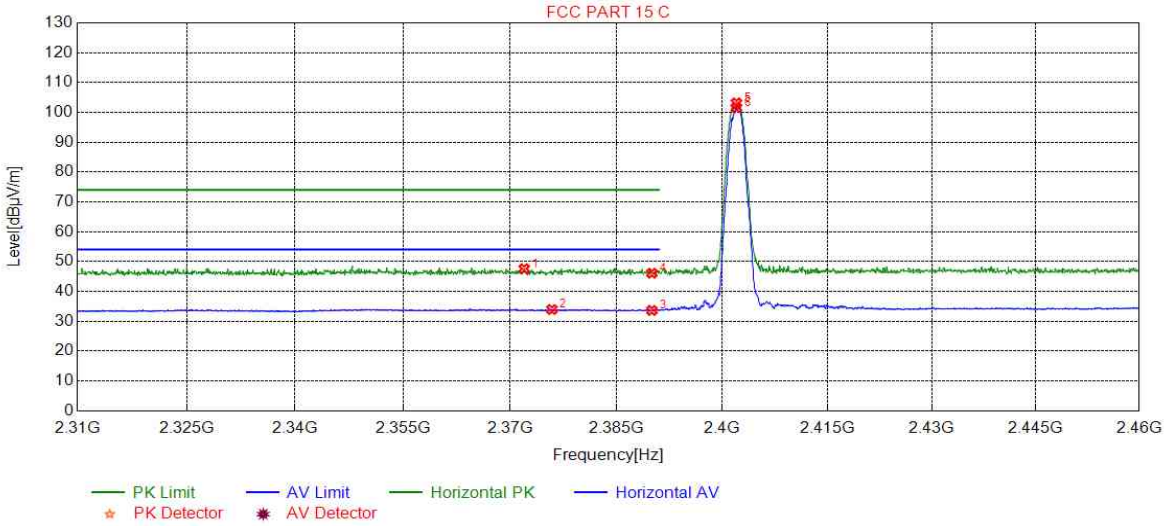
Test Procedure:	a. For below 1GHz, the EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 or 10 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation. b. For above 1GHz, the EUT was placed on the top of a rotating table 1.5 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation. c. The EUT was set 3 or 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower. d. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement. e. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading. f. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode. g. Place a marker at the end of the restricted band closest to the transmit frequency to show compliance. Also measure any emissions in the restricted bands. Save the spectrum analyzer plot. Repeat for each power and modulation for lowest and highest channel h. Test the EUT in the lowest channel , the Highest channel i. The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode,And found the X axis positioning which it is worse case. j. Repeat above procedures until all frequencies measured was complete.
Exploratory Test Mode:	Non-hopping transmitting mode with all kind of modulation and all kind of data type Charge + Transmitting mode.
Final Test Mode:	Through Pre-scan, find the DH5 of data type and GFSK modulation is the worst case. Pretest the EUT at Charge + Transmitting mode, Only the worst case is recorded in the report.
Instruments Used:	Refer to section 5.10 for details
Test Results:	Pass

4.12.1 Test Plots

4.12.1.1 Worst Case Mode (GFSK(DH5))

4.12.1.2 GFSK_Channel 0

Test Graph



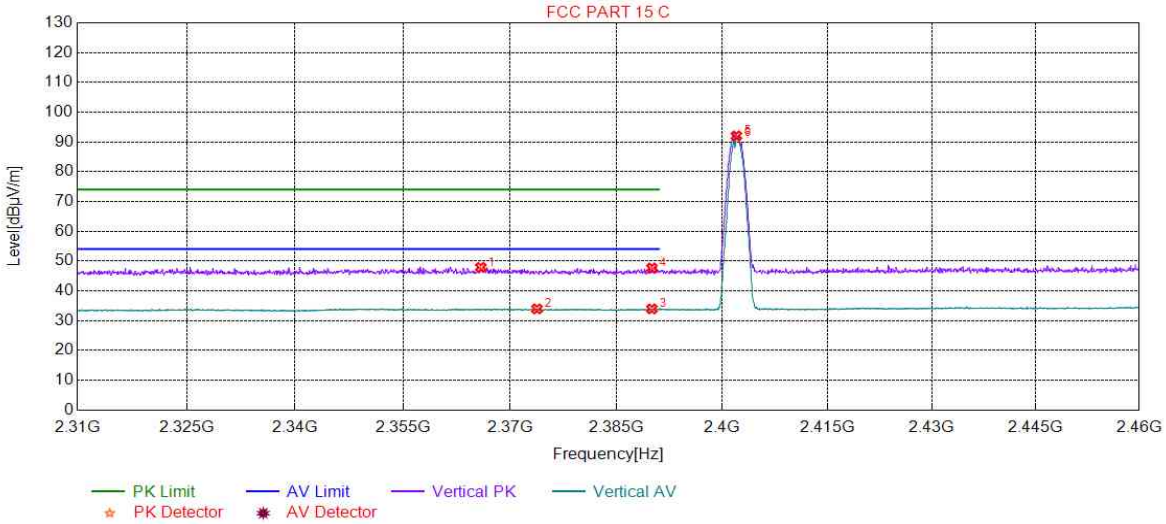
Suspected List

Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2371.98	47.58	8.03	74.00	26.42	150	356	Horizontal
2	2375.88	33.90	7.95	54.00	20.10	150	299	Horizontal
3	2390.00	33.61	7.98	54.00	20.39	150	341	Horizontal
4	2390.00	46.07	7.98	74.00	27.93	150	83	Horizontal
5	2402.00	103.16	8.06	0.00	-103.16	150	273	Horizontal
6	2402.00	101.55	8.06	0.00	-101.55	150	314	Horizontal

Final Data List

4.12.1.3 GFSK_Channel 0

Test Graph



Suspected List

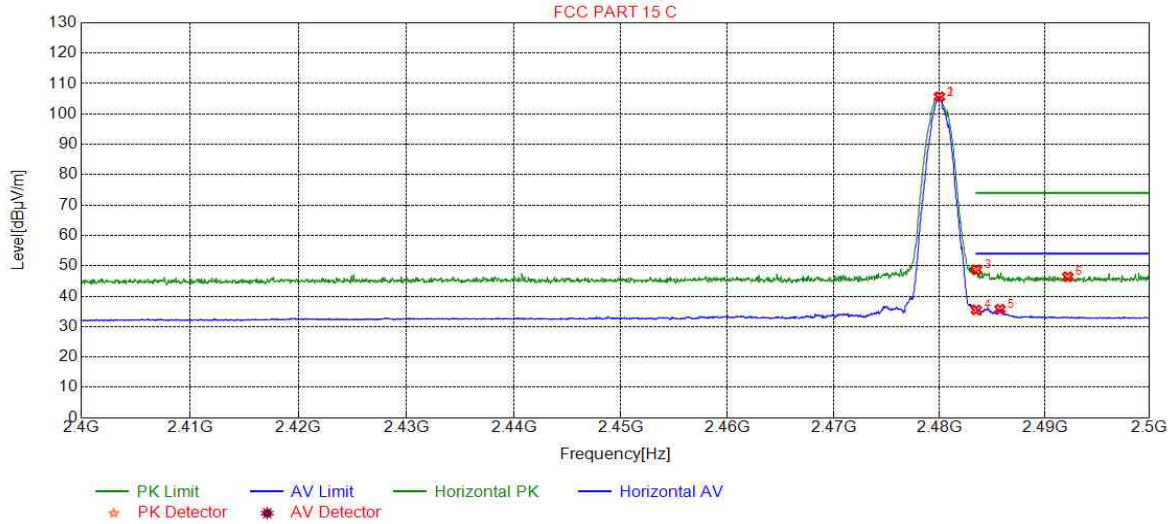
Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2365.90	47.85	8.06	74.00	26.15	150	325	Vertical
2	2373.78	33.91	7.98	54.00	20.09	150	172	Vertical
3	2390.00	33.91	7.98	54.00	20.09	150	308	Vertical
4	2390.00	47.66	7.98	74.00	26.34	150	26	Vertical
5	2402.00	92.01	8.06	0.00	-92.01	150	209	Vertical
6	2402.00	91.61	8.06	0.00	-91.61	150	209	Vertical

Final Data List

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, China 518057 t (86-755) 26012053 f (86-755) 26710594 www.sgsgroup.com.cn
中国·深圳·科技园中区M-10栋一号厂房 邮编: 518057 t (86-755) 26012053 f (86-755) 26710594 sgs.china@sgs.com

4.12.1.4 GFSK_Channel 78

Test Graph



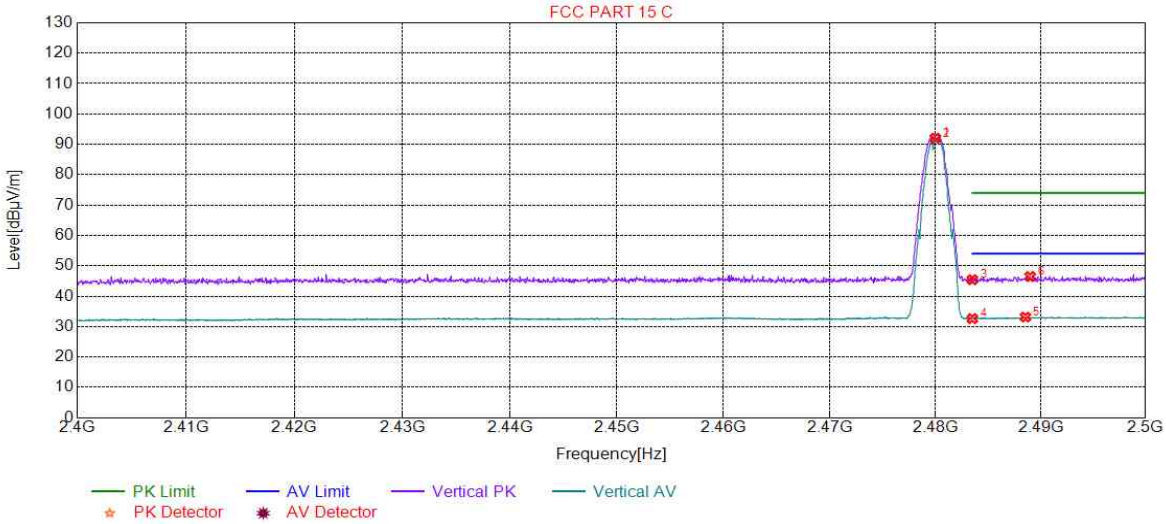
Suspected List

Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2480.00	105.64	8.54	0.00	-105.64	150	255	Horizontal
2	2480.00	105.33	8.54	0.00	-105.33	150	255	Horizontal
3	2483.50	48.68	8.50	74.00	25.32	150	334	Horizontal
4	2483.50	35.49	8.50	54.00	18.51	150	255	Horizontal
5	2485.74	35.71	8.51	54.00	18.29	150	260	Horizontal
6	2492.19	46.40	8.61	74.00	27.60	150	137	Horizontal

Final Data List

4.12.1.5 GFSK_Channel 78

Test Graph



Suspected List

Suspected List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2480.00	92.03	8.54	0.00	-92.03	150	192	Vertical
2	2480.00	91.81	8.54	0.00	-91.81	150	192	Vertical
3	2483.50	45.44	8.50	74.00	28.56	150	164	Vertical
4	2483.50	32.64	8.50	54.00	21.36	150	157	Vertical
5	2488.54	33.15	8.58	54.00	20.85	150	321	Vertical
6	2488.99	46.49	8.60	74.00	27.51	150	321	Vertical

Final Data List

Remark:
The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows:
Final Test Level =Receiver Reading + Antenna Factor + Cable Factor – Preamplifier Factor
All Modes have been tested, but only the worst case data displayed in this report.

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch
No.1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, China 518057 t (86-755) 26012053 f (86-755) 26710594 www.sgsgroup.com.cn
中国·深圳·科技园中区M-10栋一号厂房 邮编: 518057 t (86-755) 26012053 f (86-755) 26710594 sgs.china@sgs.com

5 Measurement Uncertainty (95% confidence levels, k=2)

No.	Item	Measurement Uncertainty
1	Total RF power, conducted	±0.75dB
2	RF power density, conducted	±2.84dB
3	Spurious emissions, conducted	±0.75dB
4	Radiated Spurious emission test	±4.5dB (30MHz-1GHz)
		±4.8dB (1GHz-25GHz)
5	Conduct emission test	±3.12 dB(9KHz- 30MHz)
6	Temperature test	±1℃
7	Humidity test	±3%
8	DC and low frequency voltages	±0.5%

6 Equipment List

Conducted Emission					
Test Equipment	Manufacturer	Model No.	Inventory No	Cal. date (yyyy-mm-dd)	Cal.Duedate (yyyy-mm-dd)
Shielding Room	ZhongYu Electron	GB-88	SEM001-06	2020/5/10	2023/5/9
LISN	Rohde & Schwarz	ENV216	SEM007-01	2020/7/14	2021/7/14
LISN	ETS-LINDGREN	Feb-16	SEM007-02	2020/4/1	2021/3/31
Measurement Software	AUDIX	e3 V5.4.1221d	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM024-01	2020/6/12	2021/6/11
2 Line ISN	Fischer Custom Communications Inc	FCC-TLISN-T2 02	EMC0122	2020/2/11	2021/2/10
EMI Test Receiver	Rohde & Schwarz	ESCI	SEM004-02	2020/3/2	2021/3/1

RF conducted test					
Test Equipment	Manufacturer	Model No.	Inventory No	Cal. date (yyyy-mm-dd)	Cal.Duedate (yyyy-mm-dd)
DC Power Supply	Agilent Technologie Inc	66311B	W009-09	2020/7/15	2021/7/15
Signal Analyzer	Rohde & Schwarz	FSV	W025-05	2020/1/3	2021/1/2
Coaxial Cable	SGS	N/A	SEM031-01	2020/6/12	2021/6/11
Attenuator	Weinschel Associates	WA41	SEM021-09	N/A	N/A
Signal Generator	KEYSIGHT	N5173B	SEM006-05	2020/7/14	2021/7/14
Temperature Chamber	GIANT FORCE	ICT-150-40-CP AR	W027-03	2020/10/27	2021/10/27
Power Meter	Rohde & Schwarz	NRVS	SEM014-02	2020/7/14	2021/7/14

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, China 518057 t (86-755) 26012053 f (86-755) 26710594 www.sgsgroup.com.cn
中国·深圳·科技园中区M-10栋一号厂房 邮编: 518057 t (86-755) 26012053 f (86-755) 26710594 sgs.china@sgs.com

RE in Chamber					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
3m Semi-Anechoic Chamber	AUDIX	N/A	SEM001-02	2018/3/13	2021/3/12
Measurement Software	AUDIX	e3V8.2014-6-2	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM026-01	2020/6/12	2021/6/11
EXA Signal Analyzer (10Hz-26.5GHz)	Agilent Technologie Inc	N9010A	SEM004-09	2020/3/12	2021/3/11
BiConiLog Antenna (26-3000MHz)	ETS-Lindgren	3142C	SEM003-01	2020/6/27	2023/6/26
Horn Antenna (0.8-18GHz)	Rohde & Schwarz	HF907	SEM003-07	2018/4/13	2021/4/12
Pre-amplifier(0.1-1.3GHz	HP	8447D	SEM005-02	2020/7/14	2021/7/14
Low Noise Amplifier(100MHz-18GHz)	Black Diamond Series	BDLNA-0118-352810	SEM005-05	2020/9/3	2021/9/2
Horn Antenna (15-40GHz)	Schwarzbeck	BBHA 9170	SEM003-15	2020/10/17	2023/10/16
Pre-amplifier(18-26GHz)	Rohde & Schwarz	CH14-H052	SEM005-17	2020/3/2	2021/3/1
Band filter	N/A	N/A	SEM023-01	N/A	N/A

RE in Chamber					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
3m Semi-Anechoic Chamber	ETS-LINDGREN	N/A	SEM001-01	2020/8/5	2023/8/4
Measurement Software	AUDIX	e3 V8.2014-6-27	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM025-01	2020/6/12	2021/6/11
MXE EMI Receiver (20Hz-8.4GHz)	Agilent Technologie	N9038A	SEM004-05	2020/7/14	2021/7/14
BiConiLog Antenna (26-3000MHz)	ETS-LINDGREN	3142C	SEM003-01	2020/6/27	2023/6/26
Pre-amplifier (0.1-1.3GHz)	Agilent Technologie	8447D	SEM005-01	2020/3/2	2021/3/1

RE in Chamber					
Test Equipment	**Manufacturer**	**Model No.**	**Inventory No**	**Cal. Date (yyyy mm-dd)**	**Cal. Due date (yyyy-mm-dd)**
10m Semi-Anechoic Chamber	SAEMC	FSAC1018	SEM001-03	2018/3/31	2021/3/30
EMI Test Receiver (9k-7GHz)	Rohde & Schwarz	ESR	SEM004-03	2020/3/2	2021/3/1
Trilog-Broadband Antenna(25M-2GHz)	Schwarzbeck	VULB9168	SEM003-18	2020/3/15	2022/3/14
Pre-amplifier (9k-1GHz)	Sonoma	310N	SEM005-03	2020/3/12	2021/3/11
Loop Antenna (9kHz-30MHz)	ETS-Lindgren	6502	SEM003-08	2020/8/22	2023/8/21
Measurement Software	AUDIX	e3 V8.2014-6-27	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM029-01	2020/6/12	2021/6/11

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, China 518057 t (86-755) 26012053 f (86-755) 26710594 www.sgsgroup.com.cn
中国·深圳·科技园中区M-10栋一号厂房 邮编: 518057 t (86-755) 26012053 f (86-755) 26710594 sgs.china@sgs.com

7 Photographs - EUT Constructional Details

Refer to Appendix A - Photographs of Set-Up for HR/2020/B0007.

The End

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch
No.1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, China 518057 t (86-755) 26012053 f (86-755) 26710594 www.sgsgroup.com.cn
中国·深圳·科技园中区M-10栋一号厂房 邮编: 518057 t (86-755) 26012053 f (86-755) 26710594 sgs.china@sgs.com